Shenzhen Huaxia Testing Technology Co., Ltd

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Report Template Version: V03
Report Template Revision Date: Mar.1st, 2017

Test Report

Report No. :	CQASZ20190800040EX-03
Applicant:	VTIN TECHNOLOGY Co.,Limited
Address of Applicant:	UNIT D 16/F ONE CAPITAL PLACE 21 LUARD ROAD WAN CHAI, Hong Kong
Manufacturer:	VTIN TECHNOLOGY Co.,Limited
Address of Manufacturer:	UNIT D 16/F ONE CAPITAL PLACE 21 LUARD ROAD WAN CHAI, Hong Kong

Equipment Under Test (EUT):

Product:	wireless mouse
Test Model No.:	PC254A
Brand Name:	VICTSING
FCC ID:	2AIL4-PC254A
Standards:	47 CFR Part 15, Subpart C Section 15.247
Date of Test:	2019-07-30 to 2019-08-28
Date of Issue:	2019-08-28
Test Result :	**PASS***

Tested By: Tom Chen.

(Tom Chen)

Reviewed By: Aaron Ma

(Aaron Ma)

Approved By:

(Jack Ai)

SHENZHEN HUAXIA TESTING TECHNOLOGY CO.,LTD 华夏准测 APPROVED

* In the configuration tested, the EUT complied with the standards specified above.

2. Version

Revision History Of Report

Report No.	Version	Description	Issue Date
CQASZ20190800040EX-03	Rev.01	Initial report	2019-08-28

3. Test Summary

Test Item	Test Requirement	Test method	Result
Antenna Requirement	47 CFR Part 15, Subpart C Section 15.203/15.247 (c)	ANSI C63.10 (2013)	PASS
AC Power Line Conducted Emission	47 CFR Part 15, Subpart C Section 15.207	ANSI C63.10 (2013)	N/A
Conducted Peak Output Power	47 CFR Part 15, Subpart C Section 15.247 (b)(1)	ANSI C63.10 (2013)	PASS
20dB Occupied Bandwidth	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS
Carrier Frequencies Separation	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS
Hopping Channel Number	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS
Dwell Time	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS
Pseudorandom Frequency Hopping Sequence	47 CFR Part 15, Subpart C Section 15.247(b)(4)&TCB Exclusion List (7 July 2002)	ANSI C63.10 (2013)	PASS
Band-edge for RF Conducted Emissions	47 CFR Part 15, Subpart C Section 15.247(d)	ANSI C63.10 (2013)	PASS
RF Conducted Spurious Emissions	47 CFR Part 15, Subpart C Section 15.247(d)	ANSI C63.10 (2013)	PASS
Radiated Spurious emissions	47 CFR Part 15, Subpart C Section 15.205/15.209	ANSI C63.10 (2013)	PASS
Restricted bands around fundamental frequency (Radiated Emission)	47 CFR Part 15, Subpart C Section 15.205/15.209	ANSI C63.10 (2013)	PASS

N/A: Not Applicable

4. Contents

5. General Information

4.1 Client Information

Applicant:	VTIN TECHNOLOGY Co.,Limited
Address of Applicant:	UNIT D 16/F ONE CAPITAL PLACE 21 LUARD ROAD WAN CHAI, Hong Kong
Manufacturer:	VTIN TECHNOLOGY Co.,Limited
Address of Manufacturer:	UNIT D 16/F ONE CAPITAL PLACE 21 LUARD ROAD WAN CHAI, Hong Kong

4.2 General Description of EUT

Product Name:	wireless mouse
Test Model No.:	PC254A
Trade Mark:	VICTSING
EUT Supports Radios application:	Bluetooth V5.0(BLE)+Bluetooth V3.0+2.4G

4.3 Product Specification subjective to this standard

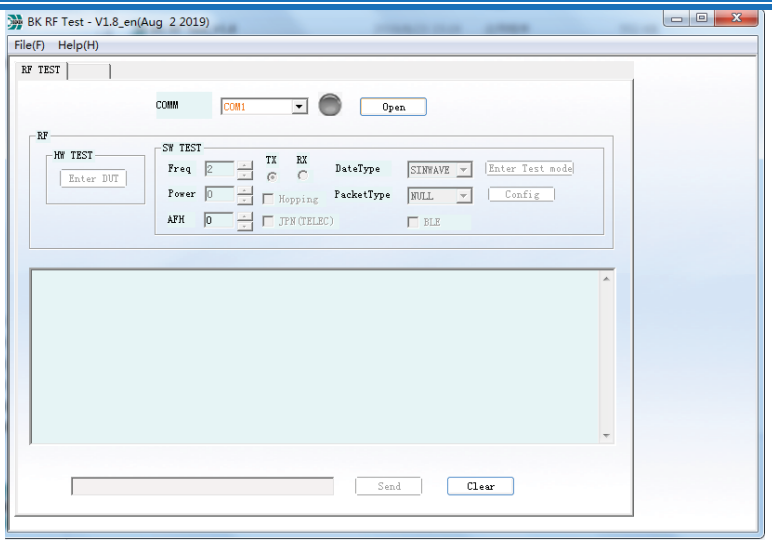
Radio function:	Bluetooth V3.0
Operation Frequency:	2402-2480MHz
Hardware Version:	V2.0
Software Version:	V1.8
Modulation Technique:	Frequency Hopping Spread Spectrum(FHSS)
Modulation Type:	GFSK, π/4DQPSK, 8DPSK
Transfer Rate:	1Mbps/2Mbps/3Mbps
Number of Channel:	79
Hopping Channel Type:	Adaptive Frequency Hopping systems
Test Power Grade:	Power level: 2
Test Software of EUT:	V1.8 (For details, refer to the software interface on page 7.)
Product Type:	☐ Mobile ☒ Portable ☐ Fix Location
Antenna Type:	PCB antenna
Antenna Gain:	0dBi
EUT Power Supply:	battery: 1.5V

Operation Frequency each of channel							
Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency
0	2402MHz	20	2422MHz	40	2442MHz	60	2462MHz
1	2403MHz	21	2423MHz	41	2443MHz	61	2463MHz
2	2404MHz	22	2424MHz	42	2444MHz	62	2464MHz
3	2405MHz	23	2425MHz	43	2445MHz	63	2465MHz
4	2406MHz	24	2426MHz	44	2446MHz	64	2466MHz
5	2407MHz	25	2427MHz	45	2447MHz	65	2467MHz
6	2408MHz	26	2428MHz	46	2448MHz	66	2468MHz
7	2409MHz	27	2429MHz	47	2449MHz	67	2469MHz
8	2410MHz	28	2430MHz	48	2450MHz	68	2470MHz
9	2411MHz	29	2431MHz	49	2451MHz	69	2471MHz
10	2412MHz	30	2432MHz	50	2452MHz	70	2472MHz
11	2413MHz	31	2433MHz	51	2453MHz	71	2473MHz
12	2414MHz	32	2434MHz	52	2454MHz	72	2474MHz
13	2415MHz	33	2435MHz	53	2455MHz	73	2475MHz
14	2416MHz	34	2436MHz	54	2456MHz	74	2476MHz
15	2417MHz	35	2437MHz	55	2457MHz	75	2477MHz
16	2418MHz	36	2438MHz	56	2458MHz	76	2478MHz
17	2419MHz	37	2439MHz	57	2459MHz	77	2479MHz
18	2420MHz	38	2440MHz	58	2460MHz	78	2480MHz
19	2421MHz	39	2441MHz	59	2461MHz		

Note:

In section 15.31(m), regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

Channel	Frequency
The Lowest channel	2402MHz
The Middle channel	2441MHz
The Highest channel	2480MHz


BK RF Test - V1.8_en(Aug 2 2019)
File(F) Help(H)
RF TEST
COMM
COM1
Open
RF
HW TEST
Enter DUT
SW TEST
Freq
Power
AFH
TX
RX
Hopping
JPN(TELEC)
DateType
SINWAVE
PacketType
NULL
BLE
Enter Test mode
Config
Send
Clear

4.4 Test Environment

Operating Environment:	
Radiated Emission	
Temperature:	25.4 °C
Humidity:	52 % RH
Atmospheric Pressure:	992mbar
RF item test（RF test room）	
Temperature:	26.7.5 °C
Humidity:	57 % RH
Atmospheric Pressure:	992mbar
Test Mode:	Use test software to set the lowest frequency, the middle frequency and the highest frequency keep transmitting of the EUT. Note: In the process of transmitting of EUT, the duty cycle ＞98%.

4.5 Description of Support Units

The EUT has been tested with associated equipment below.

Description	Manufacturer	Model No.	Remark	FCC certification
PC	Lenovo	ThinkPad E450C	Provide by lab	FCC ID
AC/DC Adapter	Lenovo	ADLX65NLC3A	Provide by lab	FCC SDOC

4.6 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate.

The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities.

The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 „Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements“ and is documented in the **Shenzhen Huaxia Testing Technology Co., Ltd.** quality system acc. to DIN EN ISO/IEC 17025.

Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for CQA laboratory is reported:

No.	Item	Uncertainty	Notes
1	Radiated Emission (Below 1GHz)	5.12dB	(1)
2	Radiated Emission (Above 1GHz)	4.60dB	(1)
3	Conducted Disturbance (0.15~30MHz)	3.34dB	(1)
4	Radio Frequency	3×10^{-8}	(1)
5	Duty cycle	0.6 %.	(1)
6	Occupied Bandwidth	1.1%	(1)
7	RF conducted power	0.86dB	(1)
8	RF power density	0.74	(1)
9	Conducted Spurious emissions	0.86dB	(1)
10	Temperature test	0.8℃	(1)
11	Humidity test	2.0%	(1)
12	Supply voltages	0.5 %.	(1)
13	Frequency Error	5.5 Hz	(1)

(1)This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

4.7 Test Facility

Shenzhen Huaxia Testing Technology Co., Ltd,

1F., Block A of Tongsheng Technology Building, Huahui Road, Dalang Street, Longhua District, Shenzhen, China

The test facility is recognized, certified, or accredited by the following organizations:

- **IC Registration No.: 22984-1**

The 3m Semi-anechoic chamber of Shenzhen Huaxia Testing Technology Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L5785)**

CNAS has accredited Shenzhen Huaxia Testing Technology Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **A2LA (Certificate No. 4742.01)**

Shenzhen Huaxia Testing Technology Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 4742.01.

- **FCC Registration No.: 522263**

Shenzhen Huaxia Testing Technology Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.:522263

4.9 Deviation from Standards

None.

4.10 Other Information Requested by the Customer

None.

4.11 Equipment List

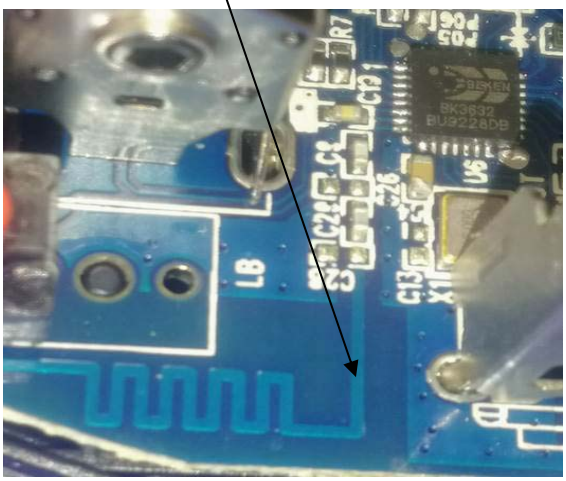
Test Equipment	Manufacturer	Model No.	Instrument No.	Calibration Date	Calibration Due Date
EMI Test Receiver	R&S	ESR7	CQA-005	2018/9/26	2019/9/25
Spectrum analyzer	R&S	FSU26	CQA-038	2018/10/28	2018/10/27
Spectrum analyzer	keysight	N9020A	CQA-105	2018/10/28	2019/10/27
Preamplifier	MITEQ	AFS4-00010300-18-10P-4	CQA-035	2018/9/26	2019/9/25
Preamplifier	MITEQ	AMF-6D-02001800-29-20P	CQA-036	2018/11/2	2019/11/1
Loop antenna	Schwarzbeck	FMZB1516	CQA-087	2018/10/28	2020/10/27
Bilog Antenna	R&S	HL562	CQA-011	2018/9/26	2020/9/25
Horn Antenna	R&S	HF906	CQA-012	2018/9/26	2020/9/25
Horn Antenna	Schwarzbeck	BBHA 9170	CQA-088	2018/9/26	2020/9/25
Coaxial Cable (Above 1GHz)	CQA	N/A	C019	2018/9/26	2019/9/25
Coaxial Cable (Below 1GHz)	CQA	N/A	C020	2018/9/26	2019/9/25
Antenna Connector	CQA	RFC-01	CQA-080	2018/9/26	2019/9/25
RF cable(9KHz~40GHz)	CQA	RF-01	CQA-079	2018/9/26	2019/9/25
Power divider	MIDWEST	PWD-2533-02-SMA-79	CQA-067	2018/9/26	2019/9/25
EMI Test Receiver	R&S	ESPI3	CQA-013	2018/9/26	2019/9/25
LISN	R&S	ENV216	CQA-003	2018/11/5	2019/11/4
Coaxial cable	CQA	N/A	CQA-C009	2018/9/26	2019/9/25

Note:

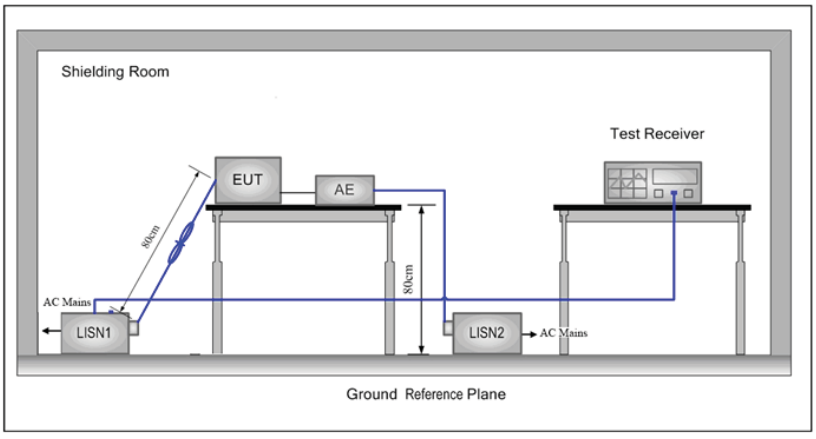
The temporary antenna connector is soldered on the PCB board in order to perform conducted tests and this temporary antenna connector is listed in the equipment list.

6. Test results and Measurement Data

5.1. Antenna Requirement

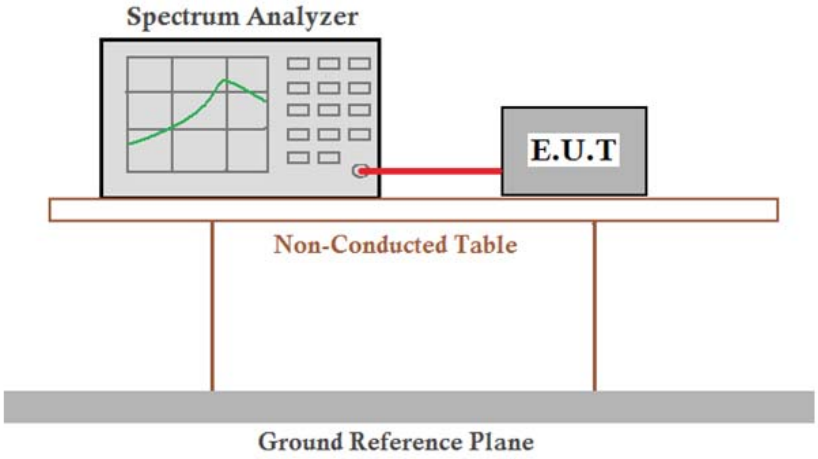
Standard requirement:	47 CFR Part 15C Section 15.203 /247(c)
15.203 requirement: An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. 15.247(b) (4) requirement: The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.	
EUT Antenna:	**PCB ANTENNA** 
The antenna is integral antenna. The best case gain of the antenna is 0dBi.	

5.2. Conducted Emissions

Test Requirement:	47 CFR Part 15C Section 15.207
Test Method:	ANSI C63.10: 2013
Test Frequency Range:	150kHz to 30MHz
Limit:	Frequency range (MHz) / Limit (dBuV): Quasi-peak / Average 0.15-0.5: 66 to 56* / 56 to 46* 0.5-5: 56 / 46 5-30: 60 / 50 * Decreases with the logarithm of the frequency.
Test Procedure:	1) The mains terminal disturbance voltage test was conducted in a shielded room. 2) The EUT was connected to AC power source through a LISN 1 (Line Impedance Stabilization Network) which provides a 50Ω/50μH + 5Ω linear impedance. The power cables of all other units of the EUT were connected to a second LISN 2, which was bonded to the ground reference plane in the same way as the LISN 1 for the unit being measured. A multiple socket outlet strip was used to connect multiple power cables to a single LISN provided the rating of the LISN was not exceeded. 3) The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, 4) The test was performed with a vertical ground reference plane. The rear of the EUT shall be 0.4 m from the vertical ground reference plane. The vertical ground reference plane was bonded to the horizontal ground reference plane. The LISN 1 was placed 0.8 m from the boundary of the unit under test and bonded to a ground reference plane for LISNs mounted on top of the ground reference plane. This distance was between the closest points of the LISN 1 and the EUT. All other units of the EUT and associated equipment was at least 0.8 m from the LISN 2. 5) In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to ANSI C63.10: 2013 on conducted measurement.
Test Setup:	
Test Mode:	N/A
Test Results:	N/A

Not application to this device

5.3. Conducted Peak Output Power

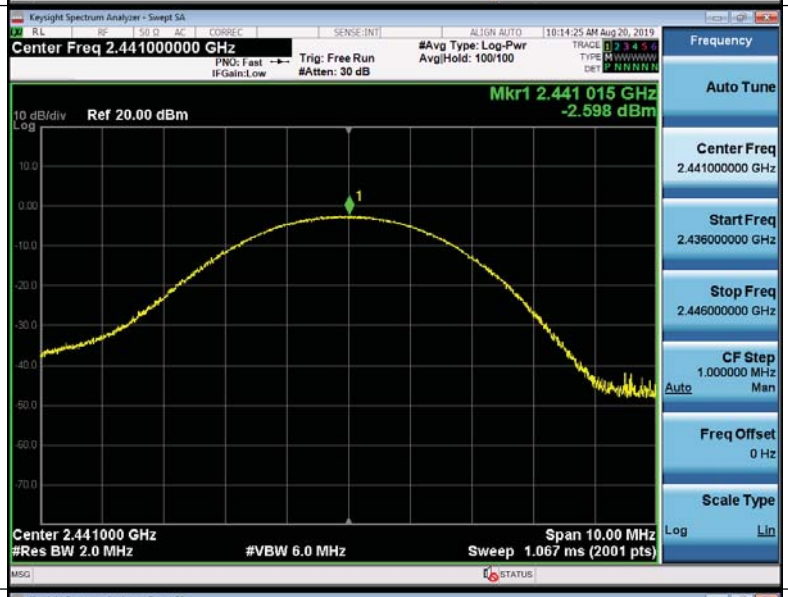
Test Requirement:	47 CFR Part 15C Section 15.247 (b)(1)
Test Method:	ANSI C63.10:2013
Test Setup:	 *Remark: Offset=Cable loss+ attenuation factor.*
Limit:	21dBm
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type. Only the worst case is recorded in the report.
Test Results:	Pass

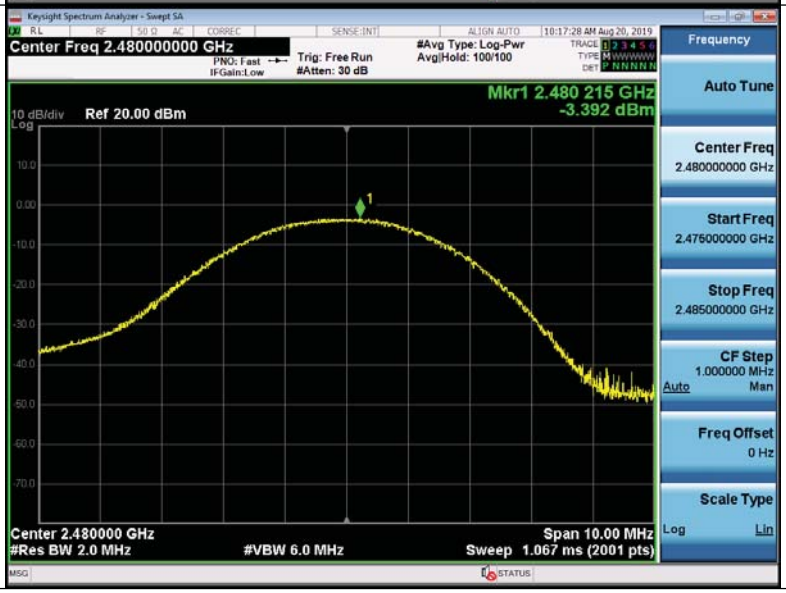
Measurement Data

GFSK mode			
Test channel	Peak Output Power (dBm)	Limit (dBm)	Result
Lowest	-3.364	**21dBm**	Pass
Middle	-3.780	**21dBm**	Pass
Highest	-4.531	**21dBm**	Pass
π/4DQPSK mode			
Test channel	Peak Output Power (dBm)	Limit (dBm)	Result
Lowest	-2.259	**21dBm**	Pass
Middle	-2.598	**21dBm**	Pass
Highest	-3.363	**21dBm**	Pass
8DPSK mode			
Test channel	Peak Output Power (dBm)	Limit (dBm)	Result
Lowest	-2.240	**21dBm**	Pass
Middle	-2.578	**21dBm**	Pass
Highest	-3.392	**21dBm**	Pass

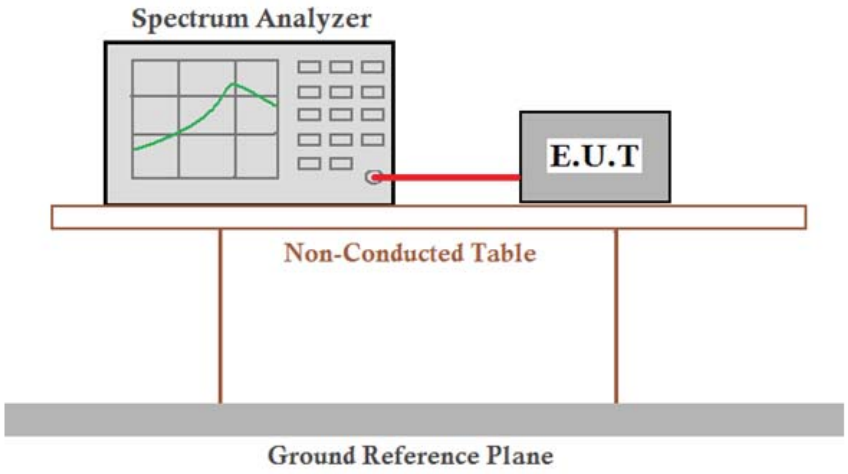
Test plot as follows:

Graphs		
GFSK/LCH		
GFSK/MCH		
GFSK/HCH		

π/4DQPSK/LCH		
π/4DQPSK/MCH		
π/4DQPSK/HCH		

8DPSK/LCH		
8DPSK /MCH		
8DPSK /HCH		

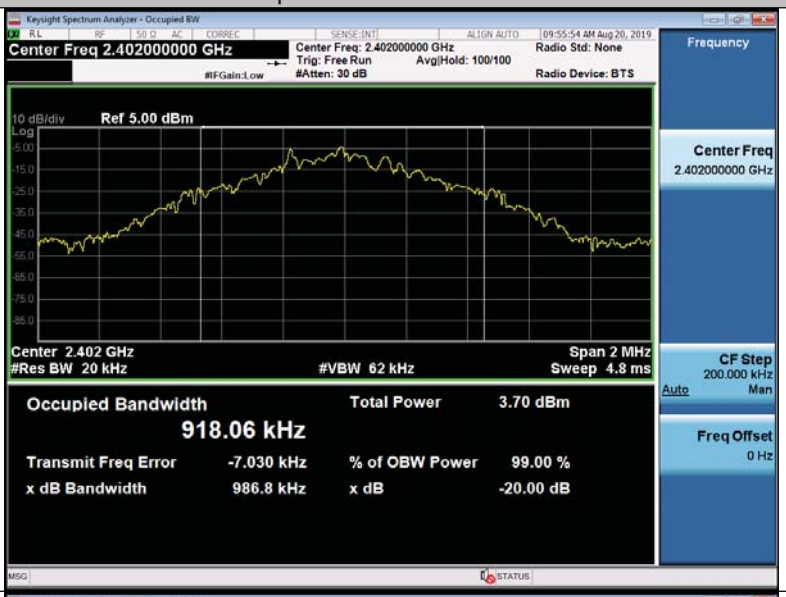
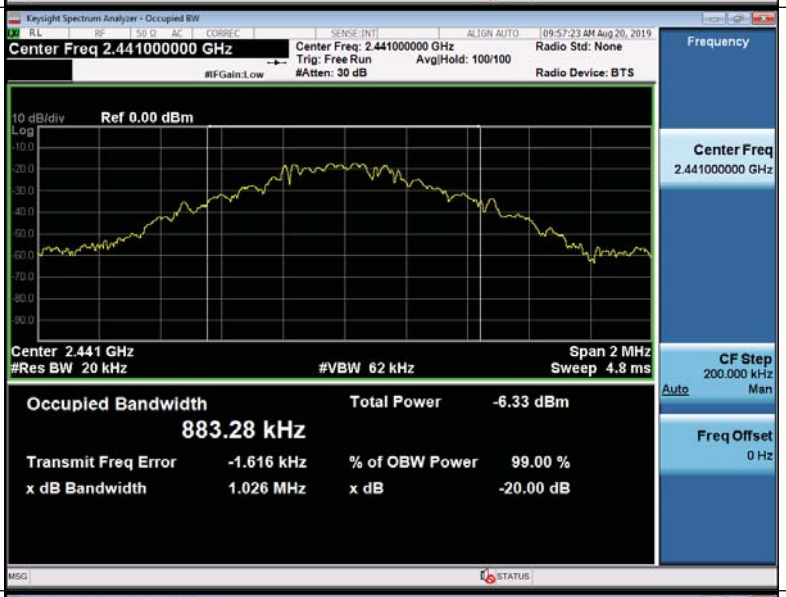
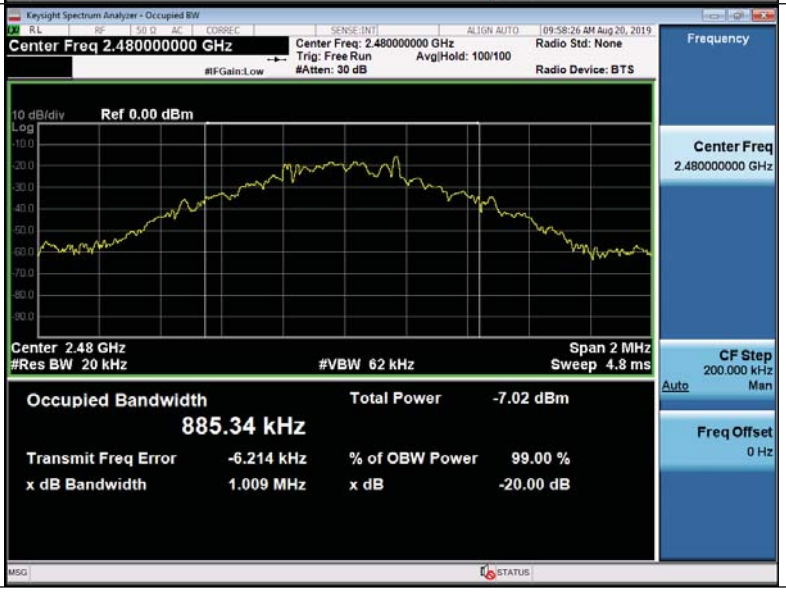
5.4. 20dB Occupy Bandwidth

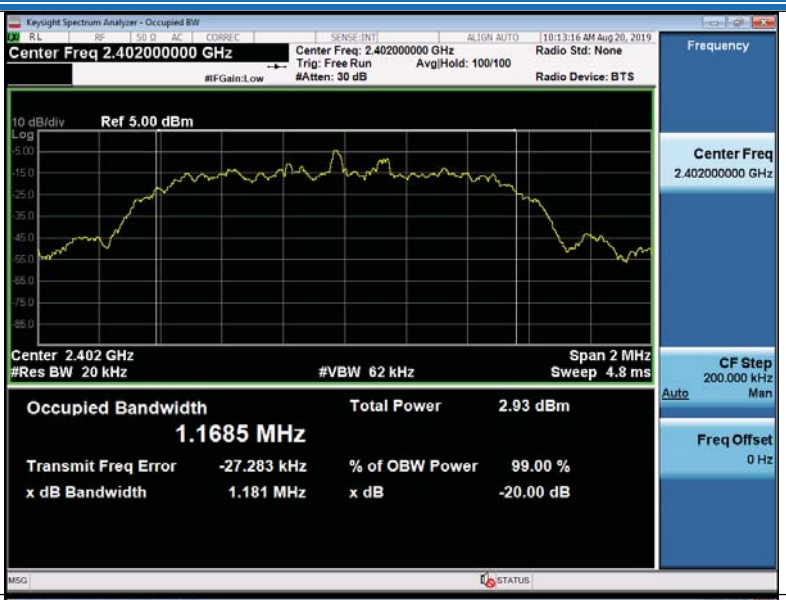
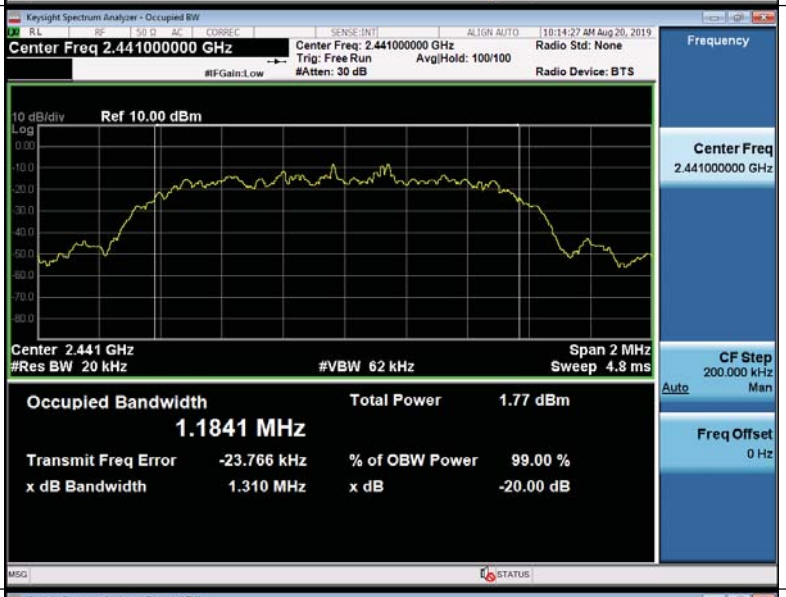
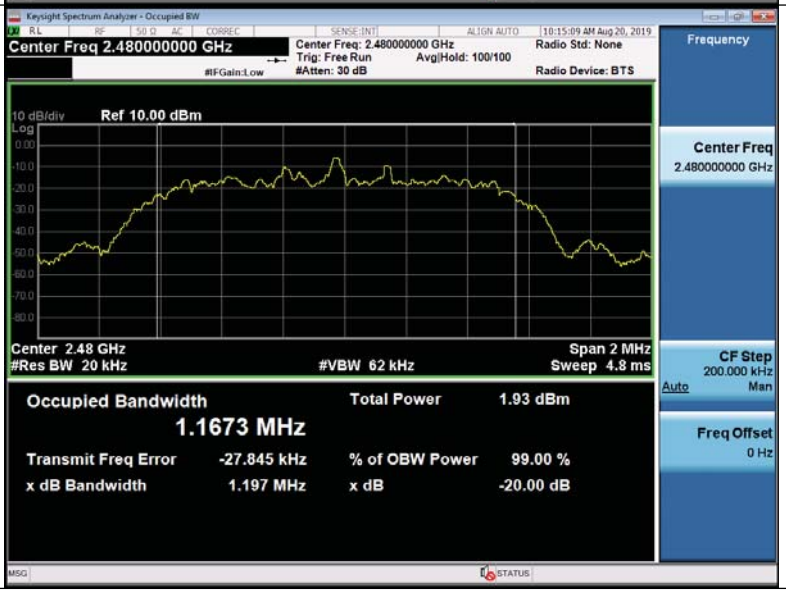
Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013
Test Setup:	 Remark: Offset=Cable loss+ attenuation factor.
Limit:	NA
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type. Only the worst case is recorded in the report.
Test Results:	Pass

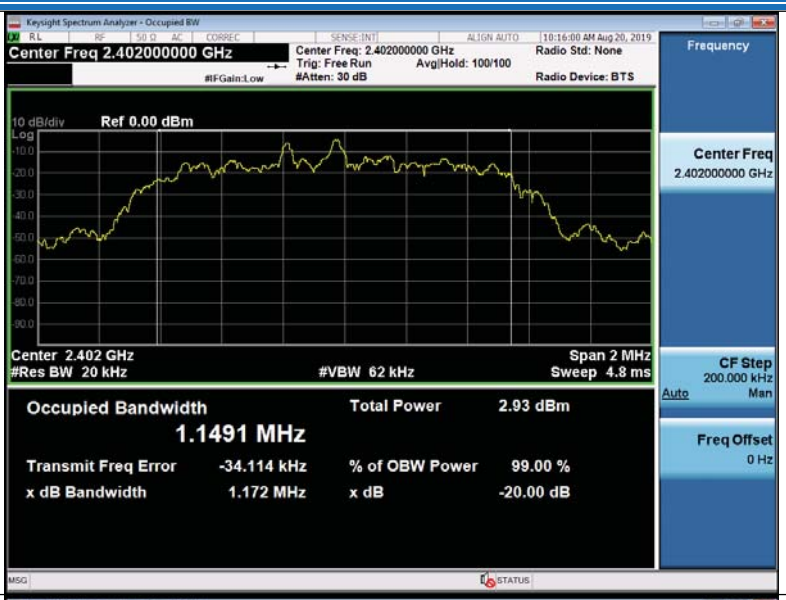
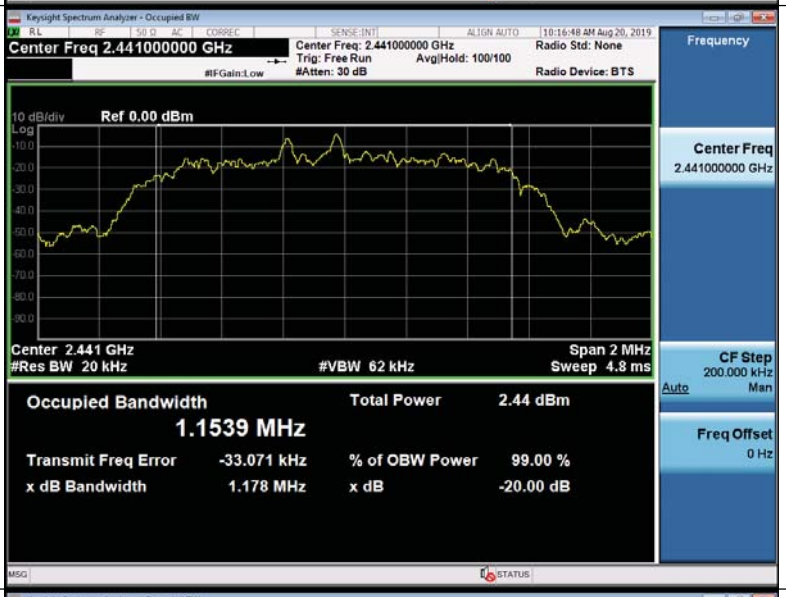
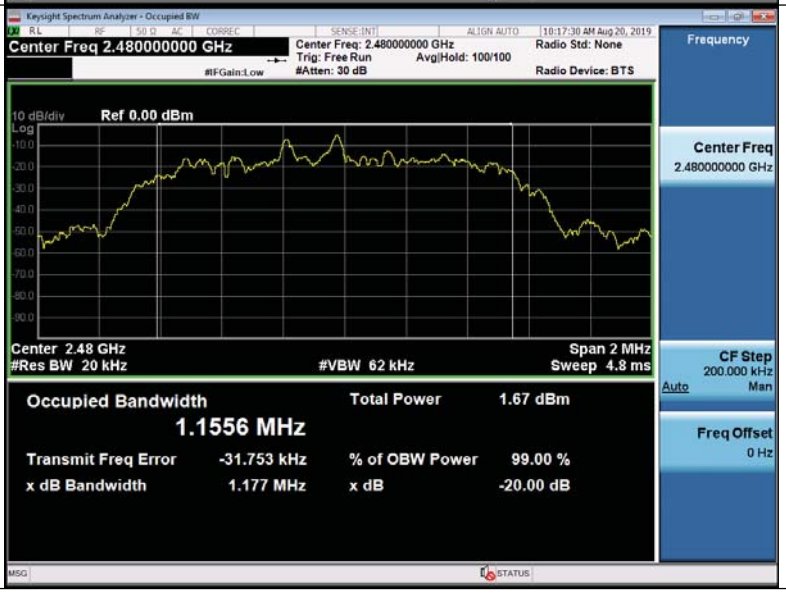
Measurement Data

Test channel	20dB Occupy Bandwidth (MHz)		
	GFSK	π/4DQPSK	8DPSK
Lowest	0.987	1.181	1.172
Middle	1.026	1.310	1.178
Highest	1.009	1.197	1.177

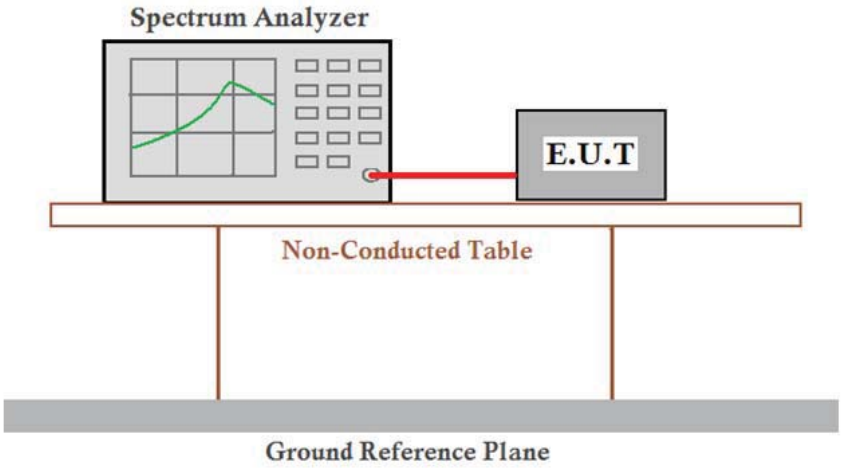
Test plot as follows:

Graphs		
GFSK/LCH		
GFSK/MCH		
GFSK/HCH		

π/4DQPSK/LCH		
π/4DQPSK/MCH		
π/4DQPSK/HCH		

8DPSK/LCH		
8DPSK /MCH		
8DPSK /HCH		

5.5. Frequencies Separation

Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013
Test Setup:	 Remark: Offset=Cable loss+ attenuation factor.
Limit:	2/3 of the 20dB bandwidth
	Remark: the transmission power is less than 0.125W.
Exploratory Test Mode:	Hopping transmitting with all kind of modulation and all kind of data type
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type. Only the worst case is recorded in the report.
Test Results:	Pass

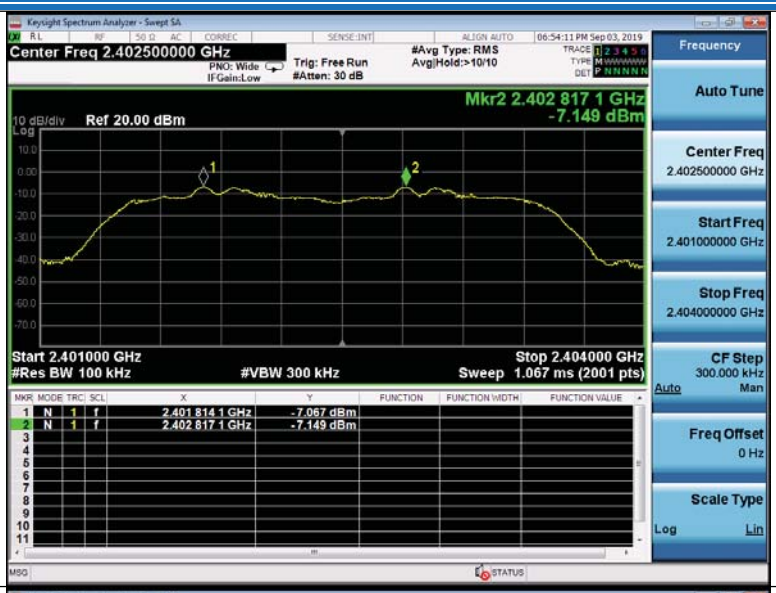
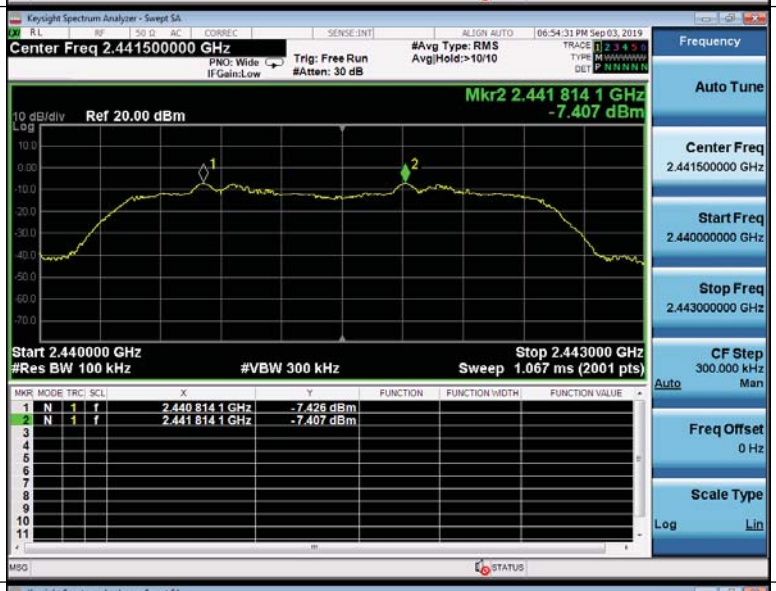
Modulation	Channel	Channel Separation (MHz)	Limit(MHz)	Result
GFSK	CH00	1.002	25KHz or 2/3*20dB bandwidth	Pass
	CH01			
	CH39	0.994		
	CH40			
	CH77	1.004		
	CH78			
pi/4DQPSK	CH00	1.322	25KHz or 2/3*20dB bandwidth	Pass
	CH01			
	CH39	1.148		

	CH40			
	CH77	1.006		
	CH78			
8DPSK	CH00	1.003	25KHz or 2/3*20dB bandwidth	Pass
	CH01			
	CH39	1.000		
	CH40			
	CH77	1.001		
	CH78			

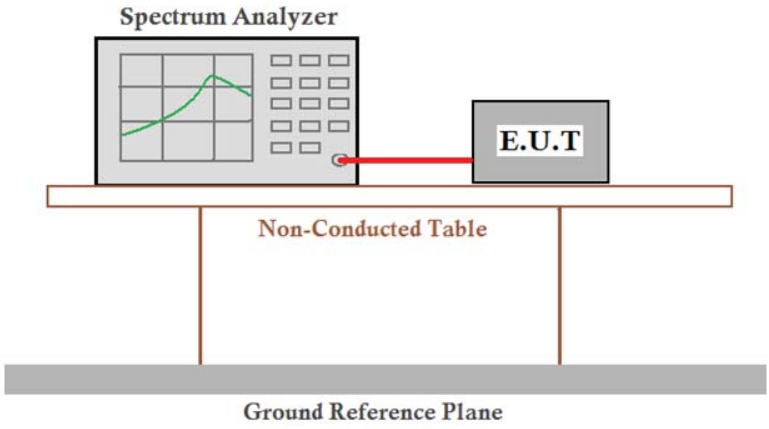
Test plot as follows:

Graphs		
GFSK / LCH		
GFSK / MCH		
GFSK / HCH		

π/4DQPSK / LCH		
π/4DQPSK /MCH		
π/4DQPSK / HCH		

8DPSK/ LCH		
8DPSK/ MCH		
8DPSK /HCH		

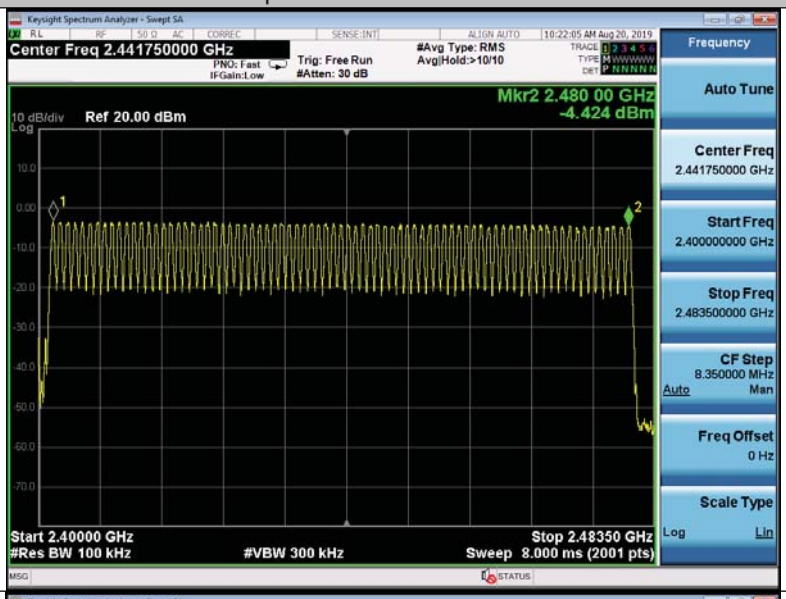
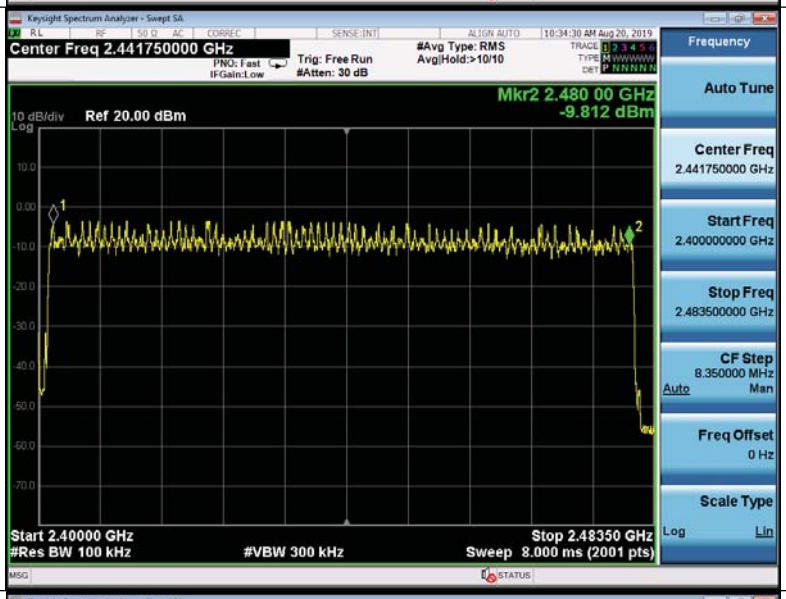
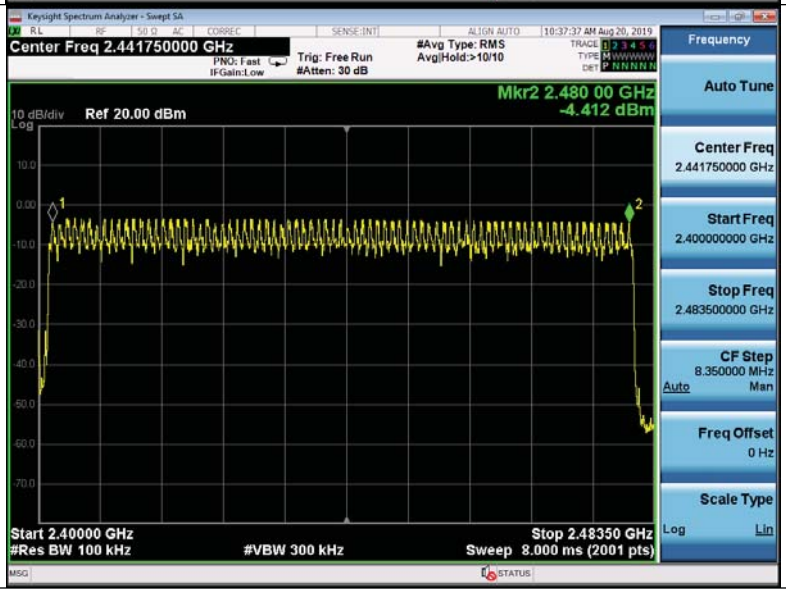
5.6. Hopping Channel Number

Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013
Test Setup:	 *Remark: Offset=Cable loss+ attenuation factor.*
Limit:	At least 15 channels
Exploratory Test Mode:	hopping transmitting with all kind of modulation and all kind of data type
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type. Only the worst case is recorded in the report.
Test Results:	Pass

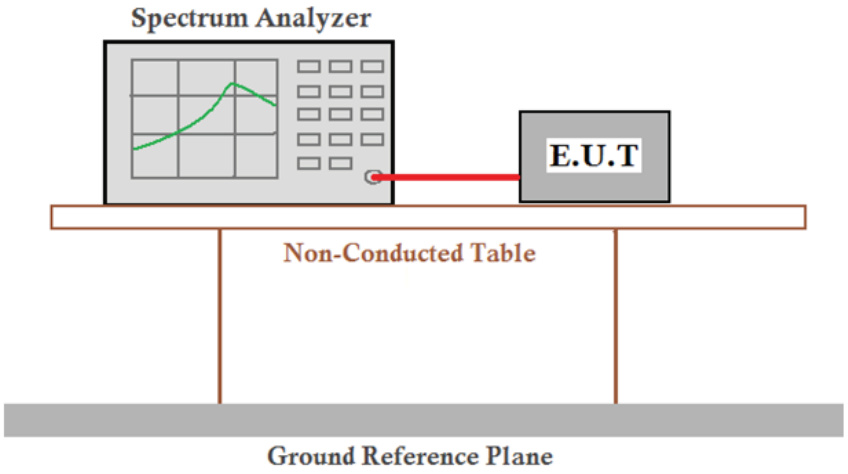
Measurement Data

Mode	Hopping channel numbers	Limit
GFSK	79	≥15
π/4DQPSK	79	≥15
8DPSK	79	≥15

Test plot as follows:

Graphs			
GFSK/Hop			
π/4DQPSK/Hop			
8DPSK/Hop			

5.7. Dwell Time

Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013
Test Setup:	 *Remark: Offset=Cable loss+ attenuation factor.*
Test Mode:	Hopping transmitting with all kind of modulation and all kind of data type.
Limit:	0.4 Second
Test Results:	Pass

Measurement Data

Mode	Packet	Channel	Burst Width [ms/hop/ch]	Dwell Time[ms]	Limit (ms)
GFSK	DH1	LCH	0.404	129.280	≤400
		MCH	0.406	129.920	≤400
		HCH	0.408	130.560	≤400
	DH3	LCH	1.656	264.960	≤400
		MCH	1.656	264.960	≤400
		HCH	1.660	265.600	≤400
	DH5	LCH	2.910	310.400	≤400
		MCH	2.905	309.867	≤400
		HCH	2.905	309.867	≤400
π/4DQPSK	2DH1	LCH	0.419	134.080	≤400
		MCH	0.419	134.080	≤400
		HCH	0.419	134.080	≤400
	2DH3	LCH	1.663	266.080	≤400
		MCH	1.671	267.360	≤400
		HCH	1.603	266.080	≤400
	2DH5	LCH	2.923	311.787	≤400

		MCH	2.913	310.720	≤400
		HCH	2.923	311.787	≤400
8DPSK	3DH1	LCH	0.419	134.080	≤400
		MCH	0.419	134.080	≤400
		HCH	0.415	132.800	≤400
	3DH3	LCH	1.663	266.080	≤400
		MCH	1.663	266.080	≤400
		HCH	1.662	265.920	≤400
	3DH5	LCH	2.922	311.680	≤400
		MCH	2.922	311.680	≤400
		HCH	2.927	312.213	≤400

Remark:

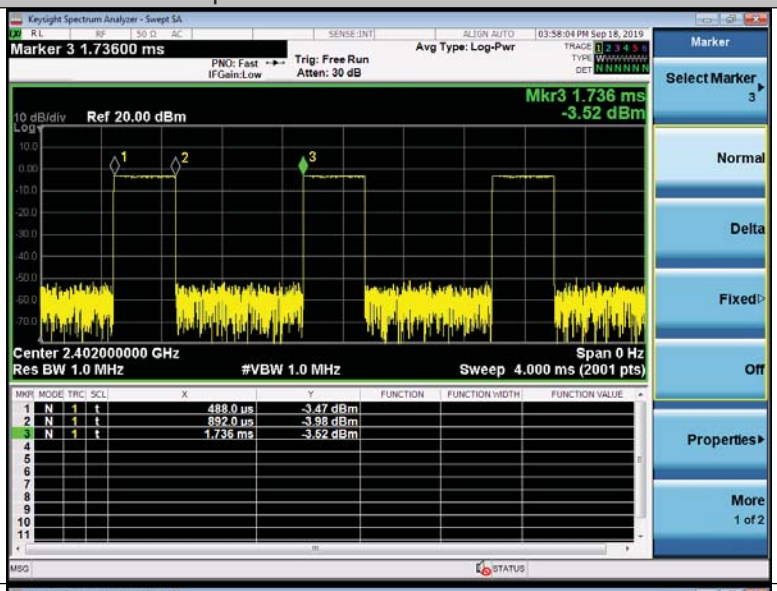
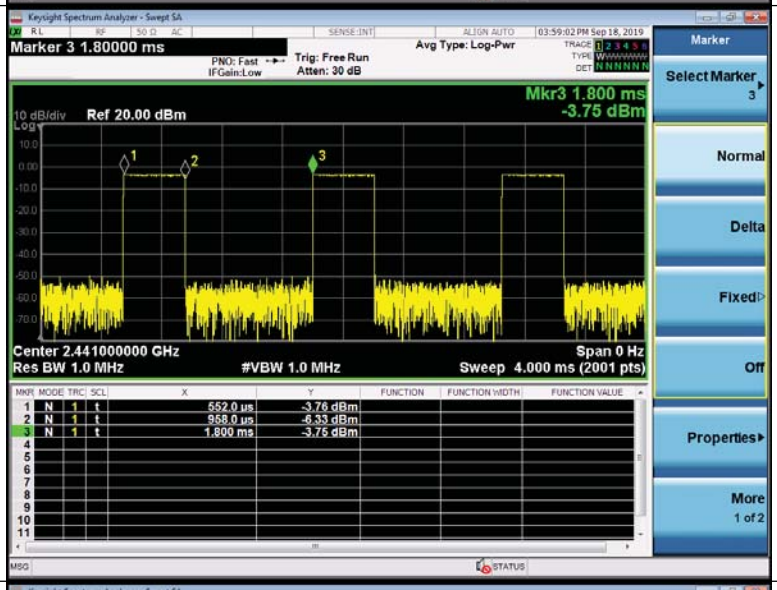
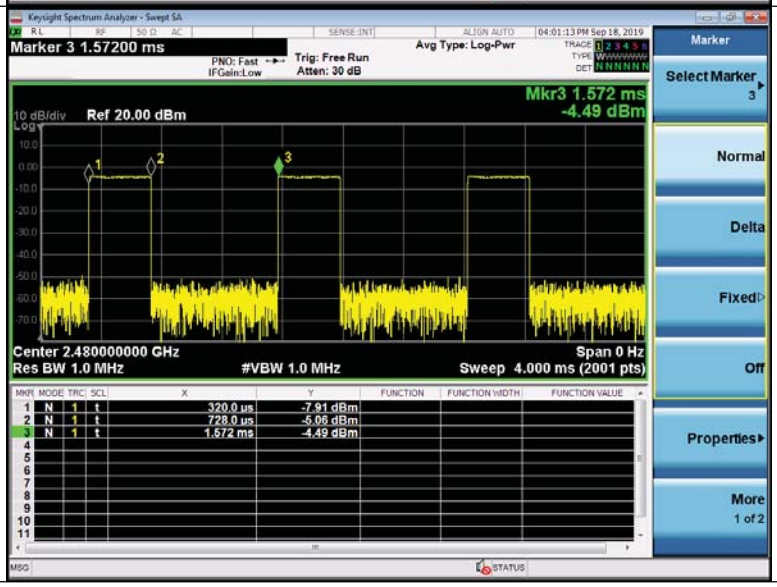
The test period: T= 0.4 Second/Channel x 79 Channel = 31.6 s

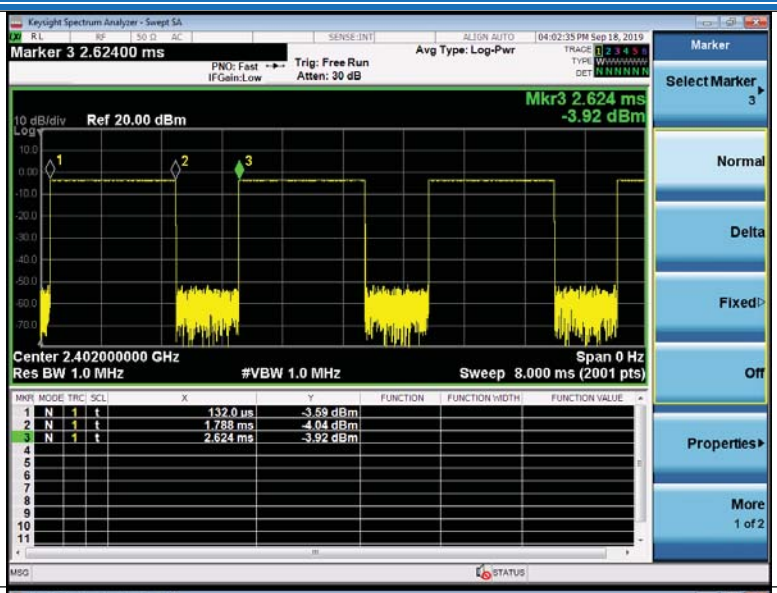
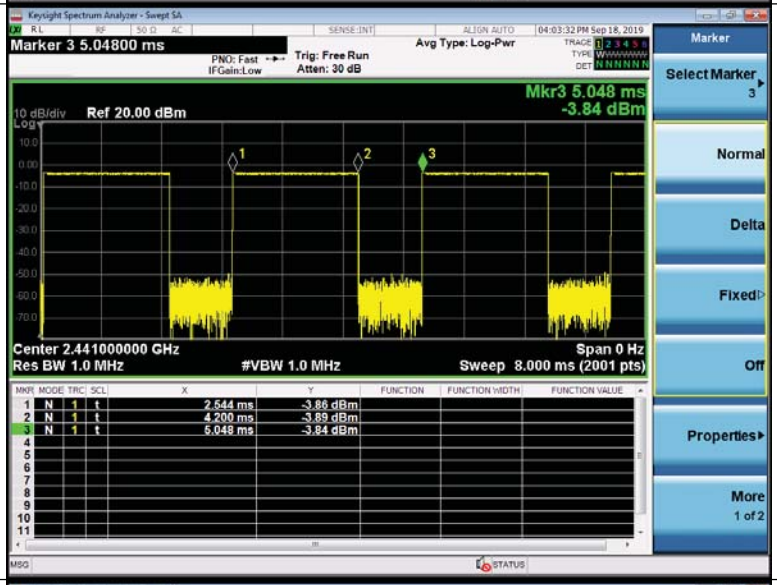
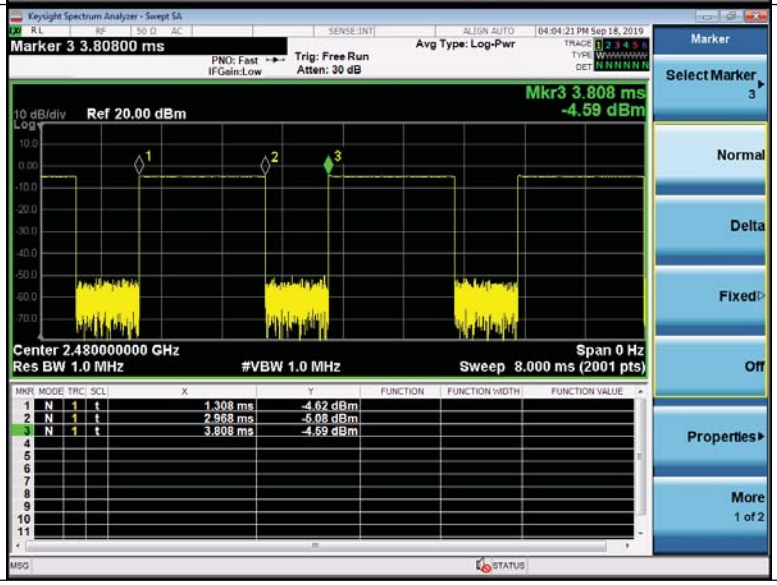
DH1/2DH1/3DH1 Dwell time = Burst Width(ms)*(1600/ (2*79))*31.6

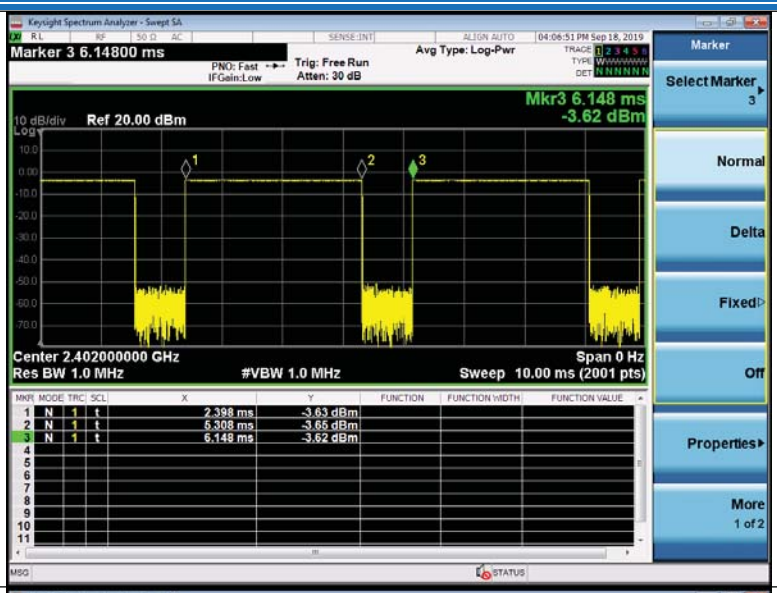
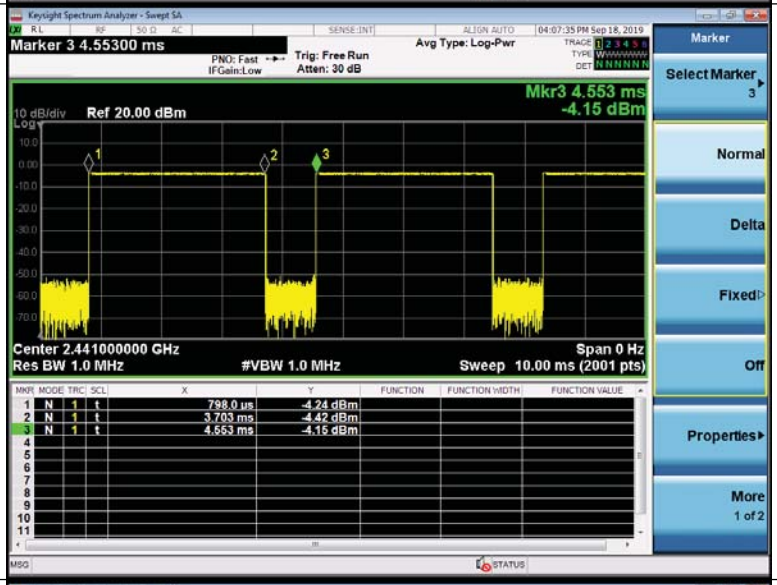
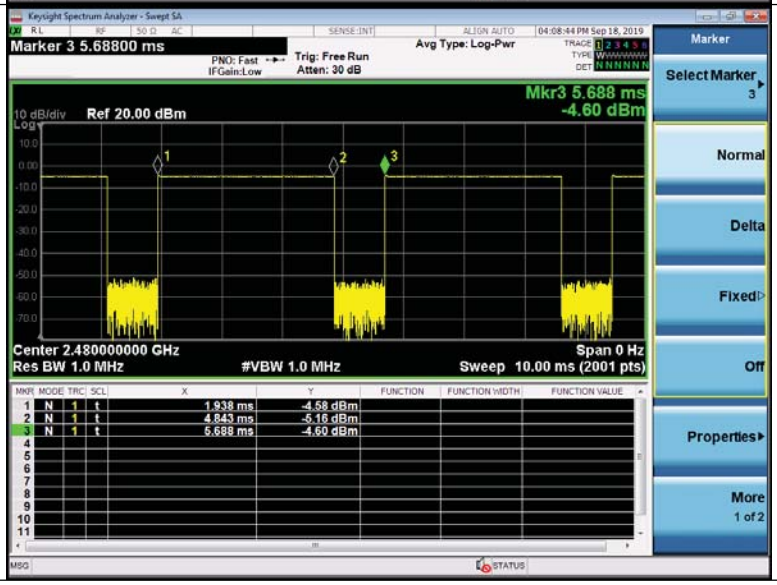
DH3/2DH3/3DH3 Dwell time = Burst Width (ms)*(1600/ (4*79))*31.6

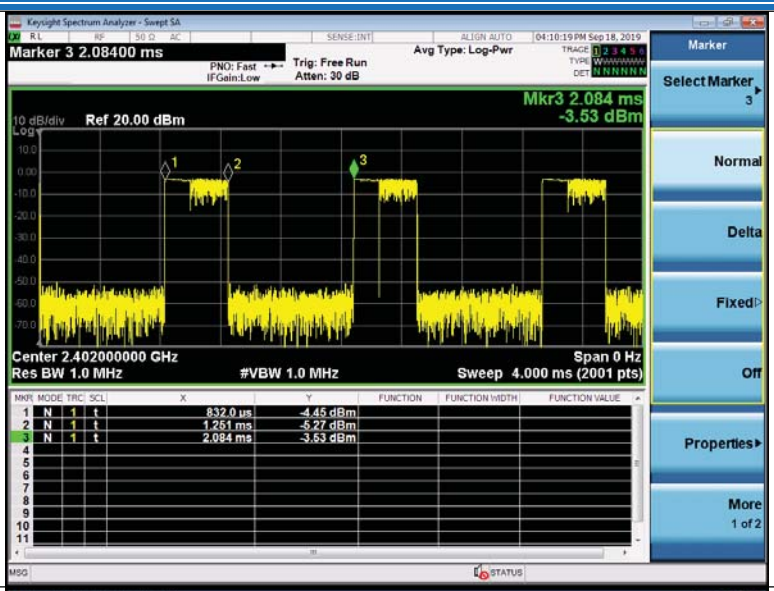
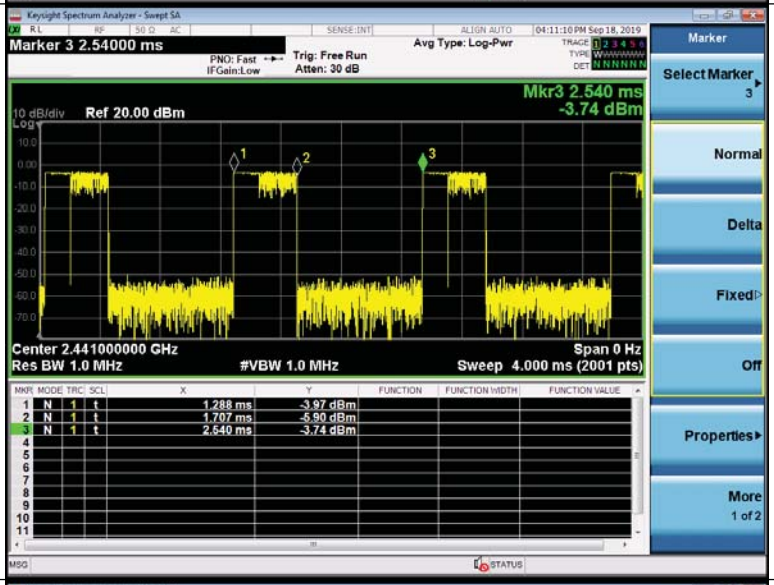
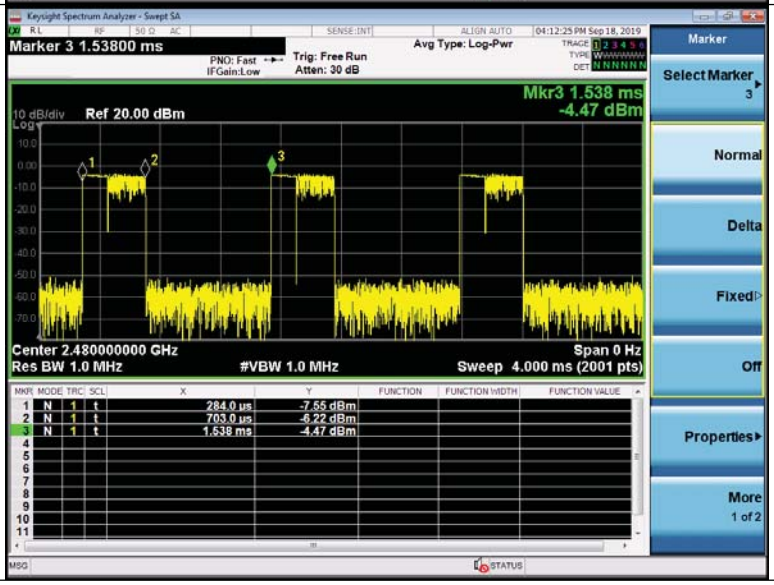
DH5/2DH5/3DH5 Dwell time = Burst Width (ms)*(1600/ (6*79))*31.6

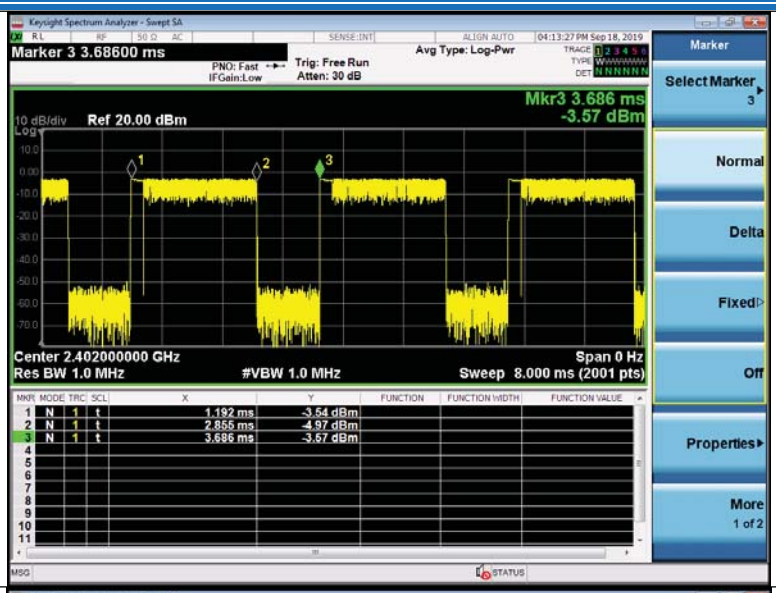
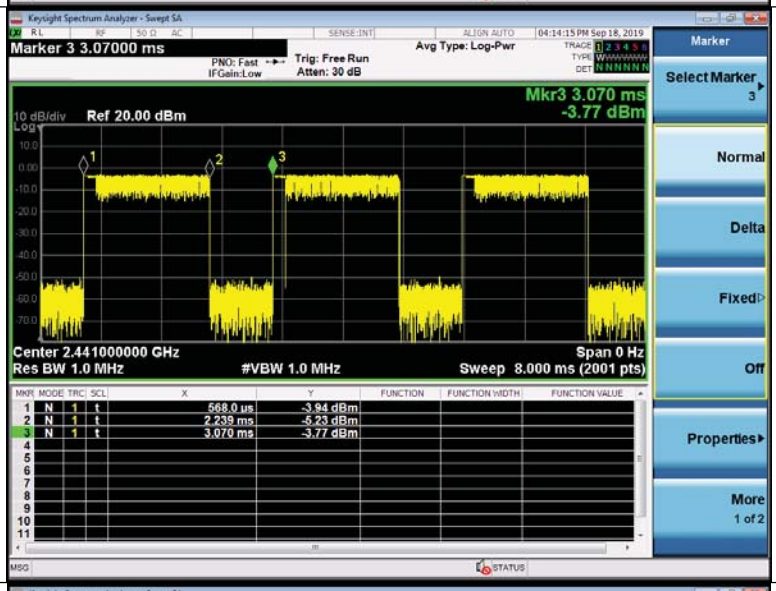
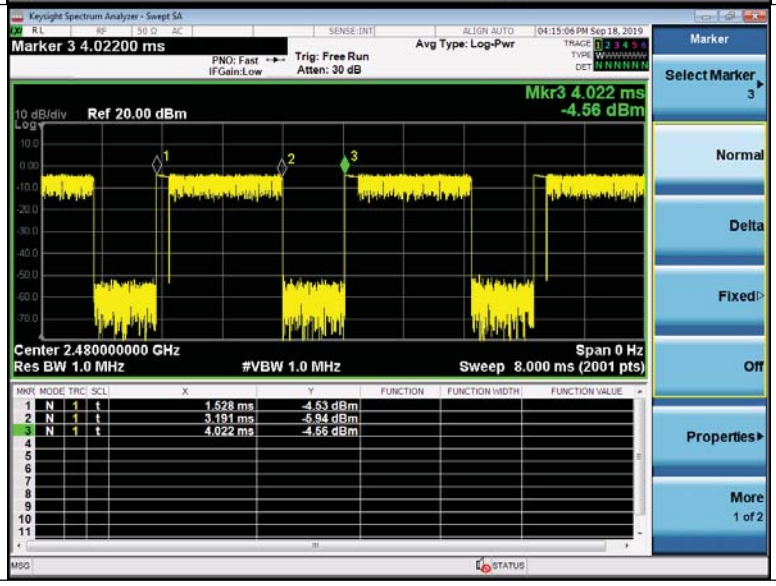
Test plot as follows:

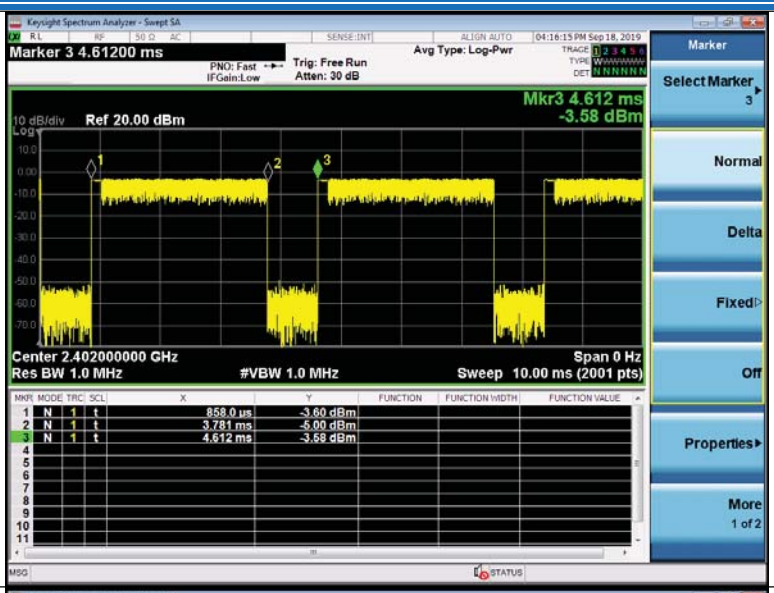
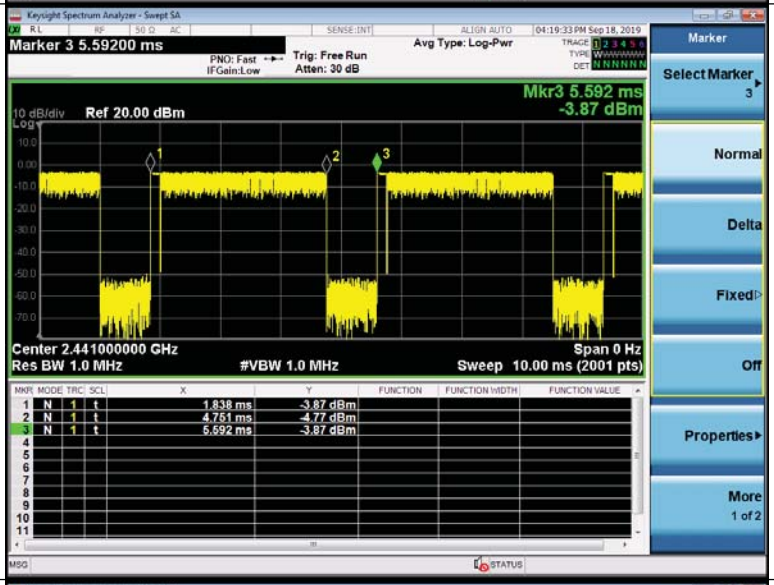
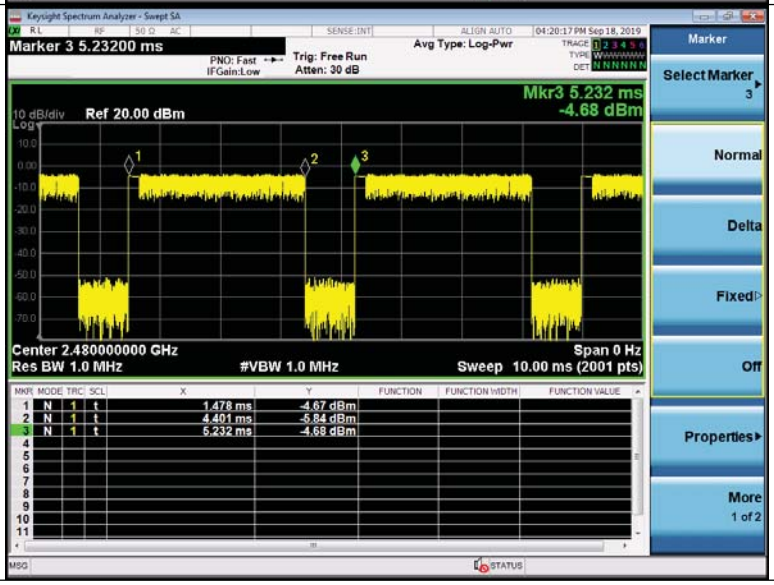
Graphs		
GFSK_DH1/LCH		
GFSK_DH1/MCH		
GFSK_DH1/HCH		

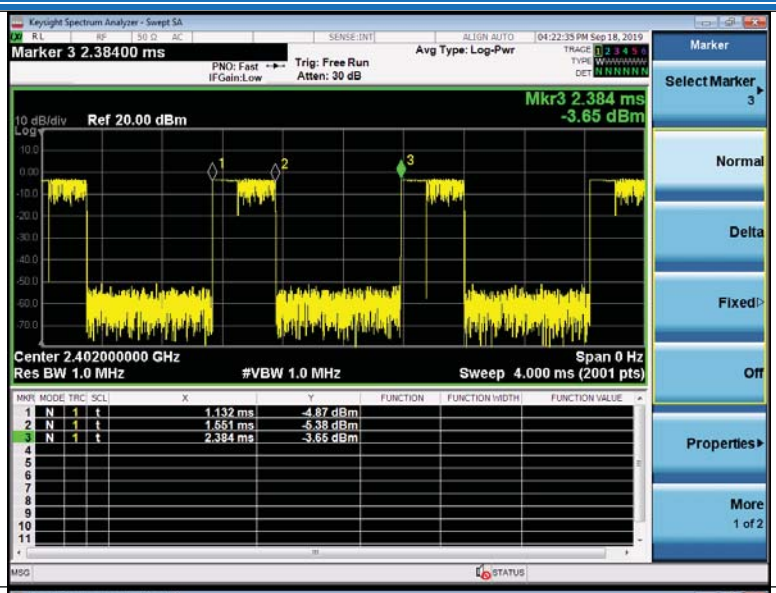
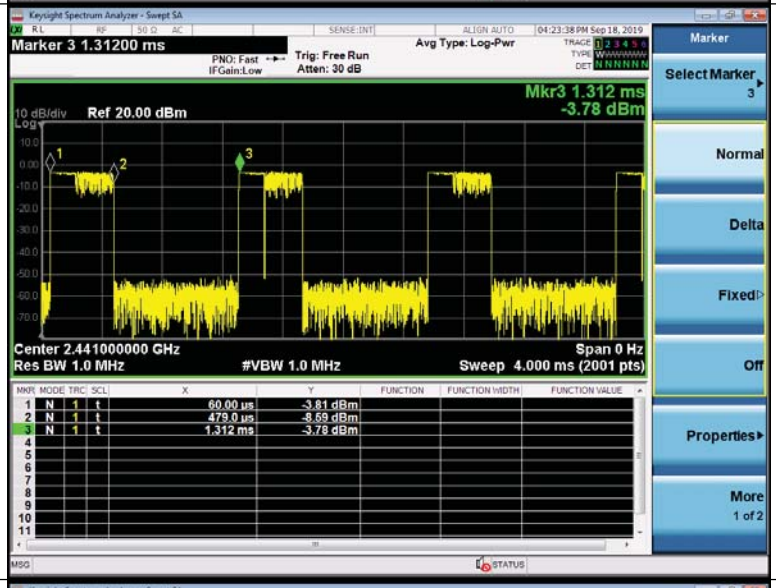
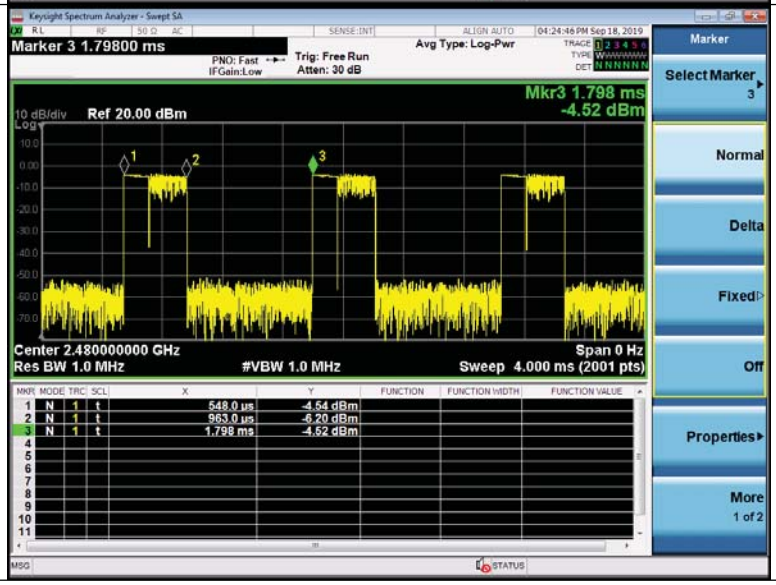
GFSK_DH3/LCH		
GFSK_DH3/MCH		
GFSK_DH3/HCH		

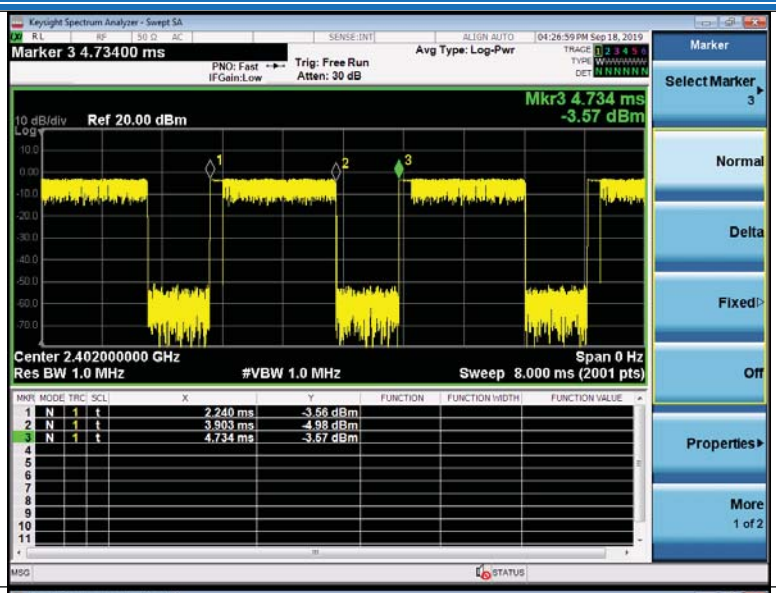
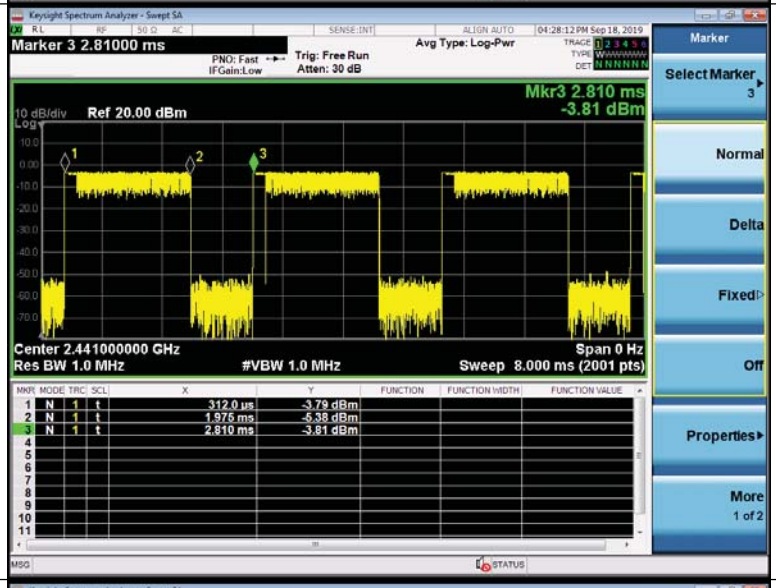
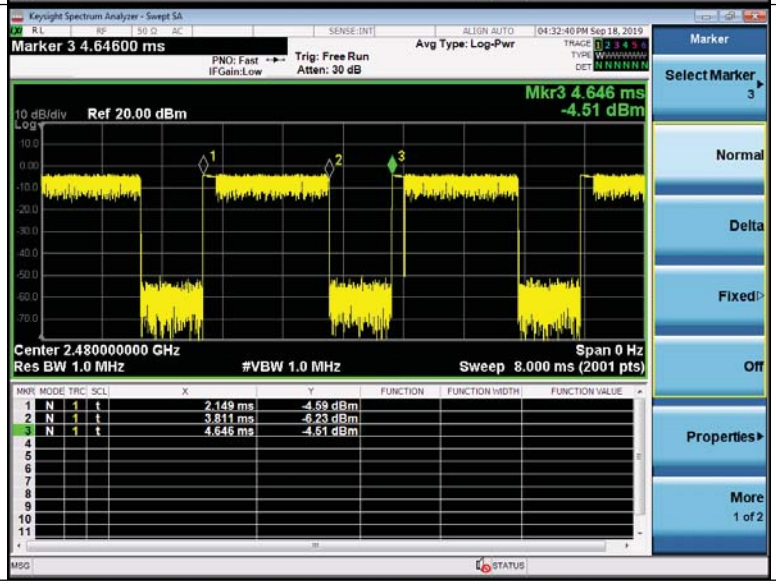
GFSK_DH5/LCH		
GFSK_DH5/MCH		
GFSK_DH5/HCH		

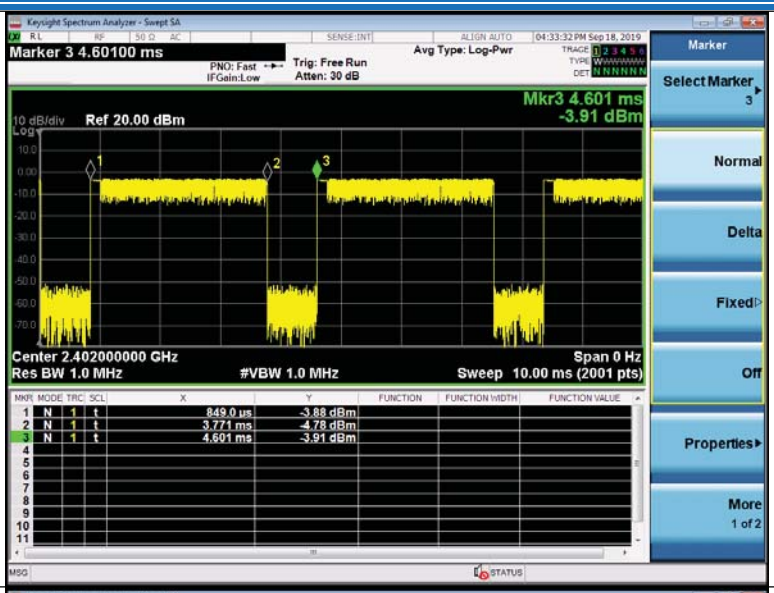
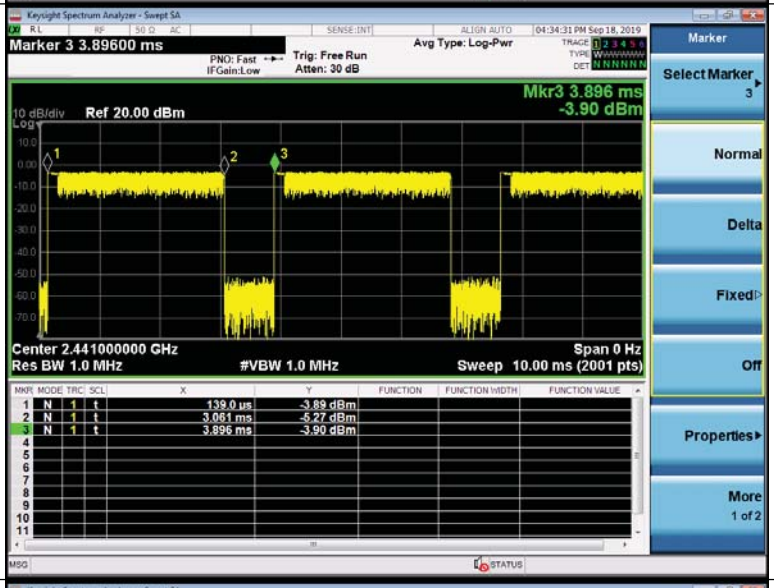
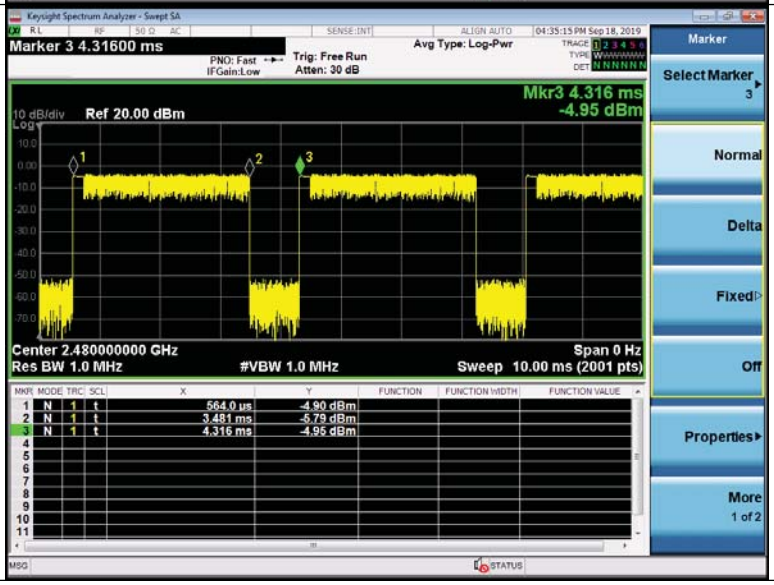
π/4DQPSK _2DH1/LCH		
π/4DQPSK _2DH1/MCH		
π/4DQPSK _2DH1/HCH		

π/4DQPSK _2DH3/LCH		
π/4DQPSK _2DH3/MCH		
π/4DQPSK _2DH3/HCH		

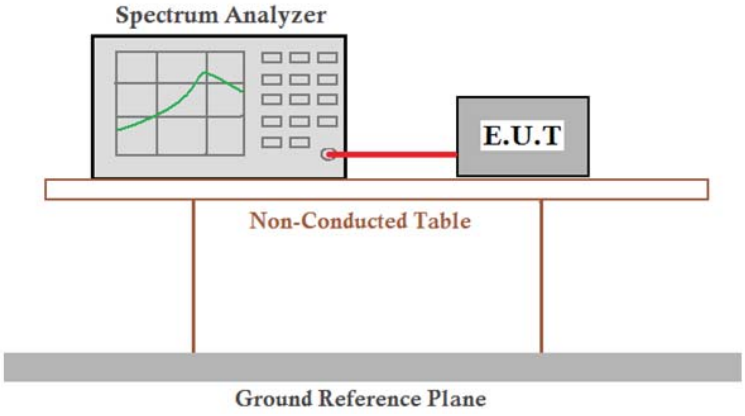
π/4DQPSK _2DH5/LCH		
π/4DQPSK _2DH5/MCH		
π/4DQPSK _2DH5/HCH		

8DPSK_3DH1/LCH		
8DPSK_3DH1/MCH		
8DPSK_3DH1/HCH		

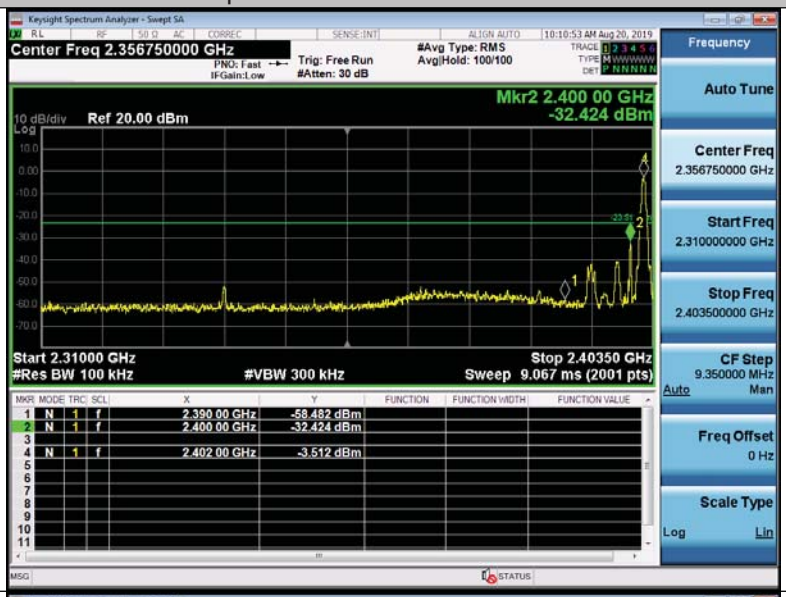
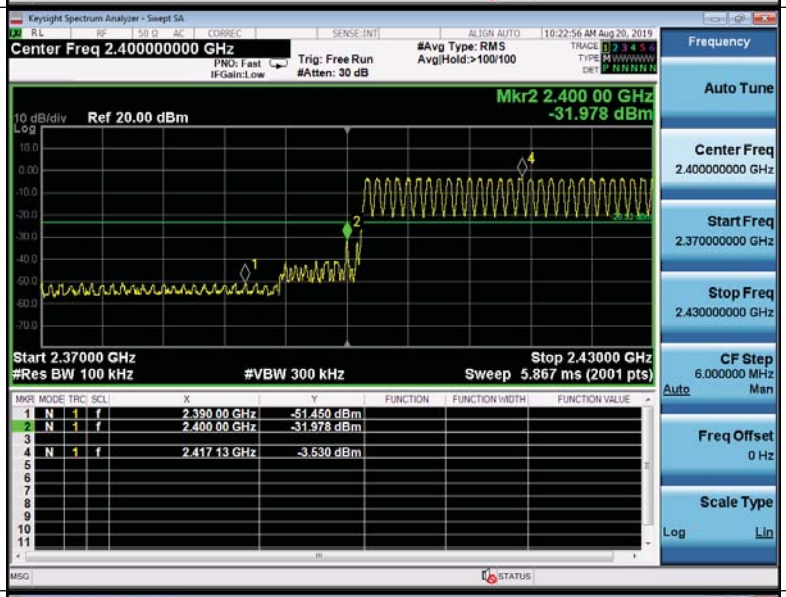
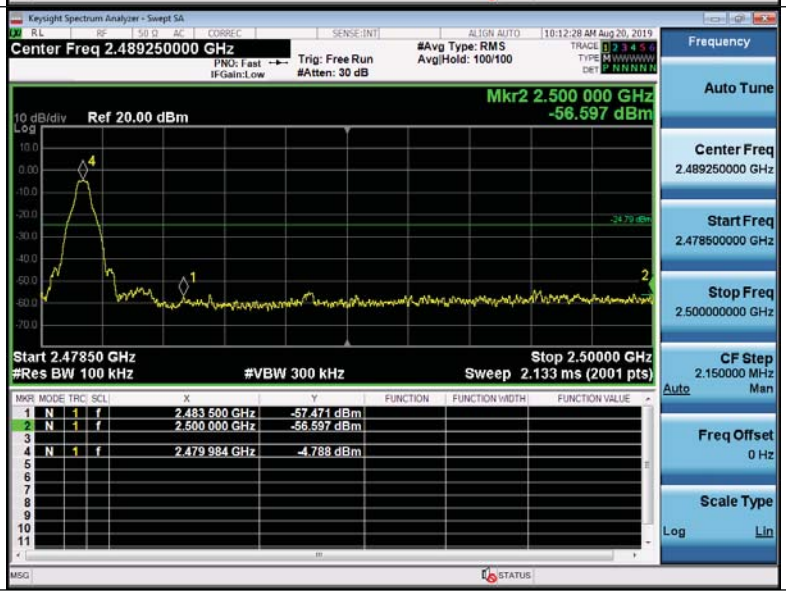
8DPSK_3DH3/LCH		
8DPSK_3DH3/MCH		
8DPSK_3DH3/HCH		

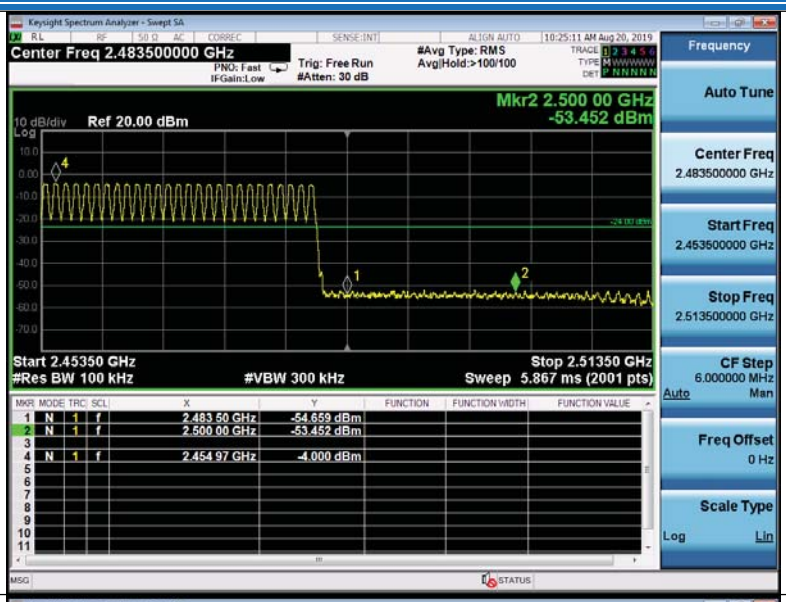
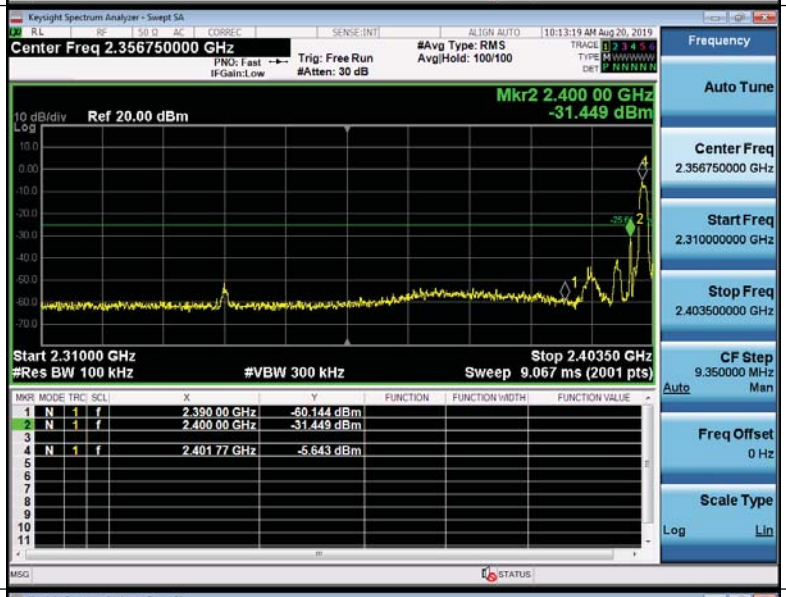
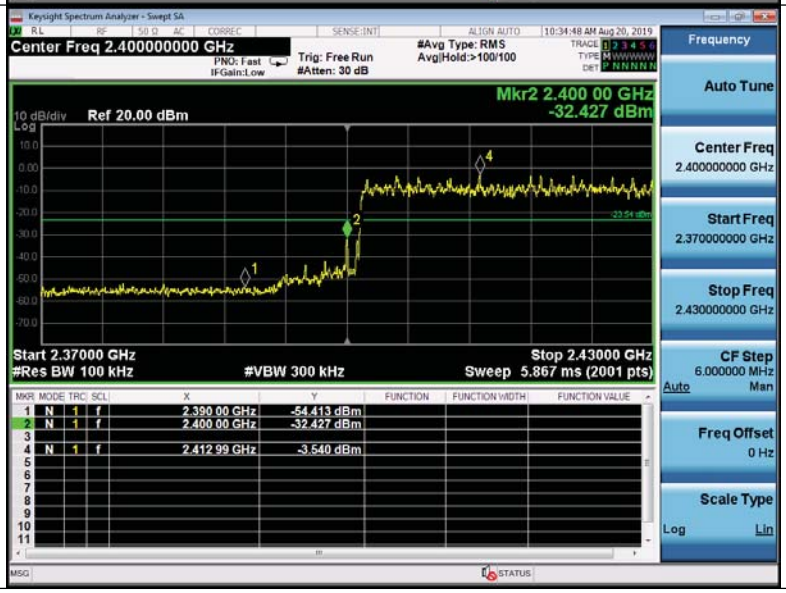
8DPSK_3DH5/LCH		
8DPSK_3DH5/MCH		
8DPSK_3DH5/HCH		

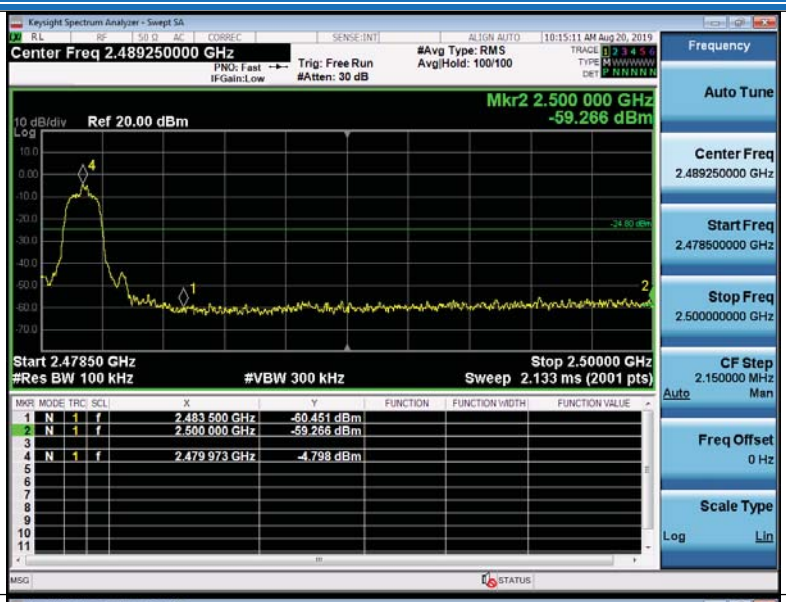
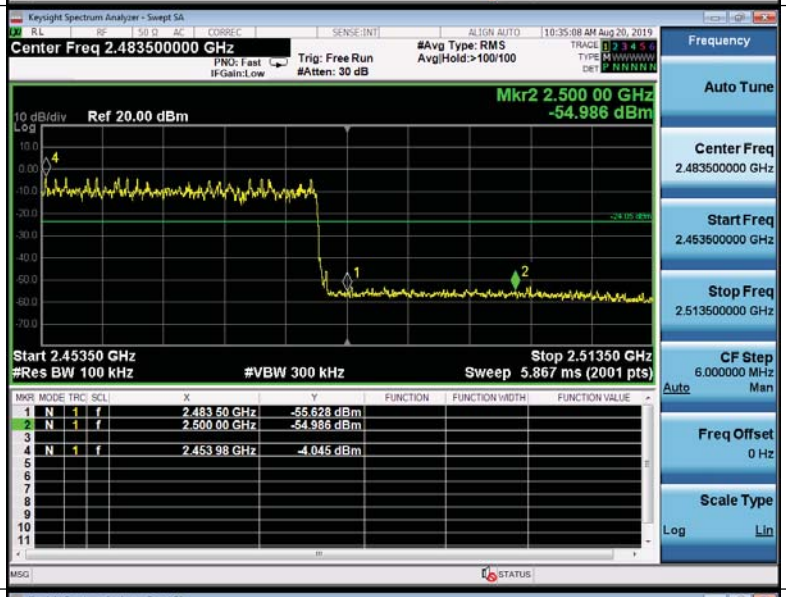
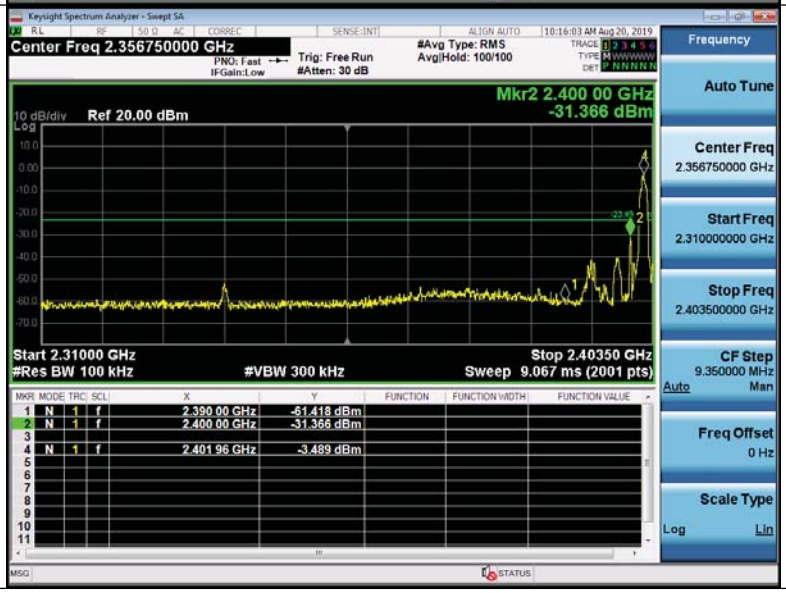
5.8. Band-edge for RF Conducted Emissions

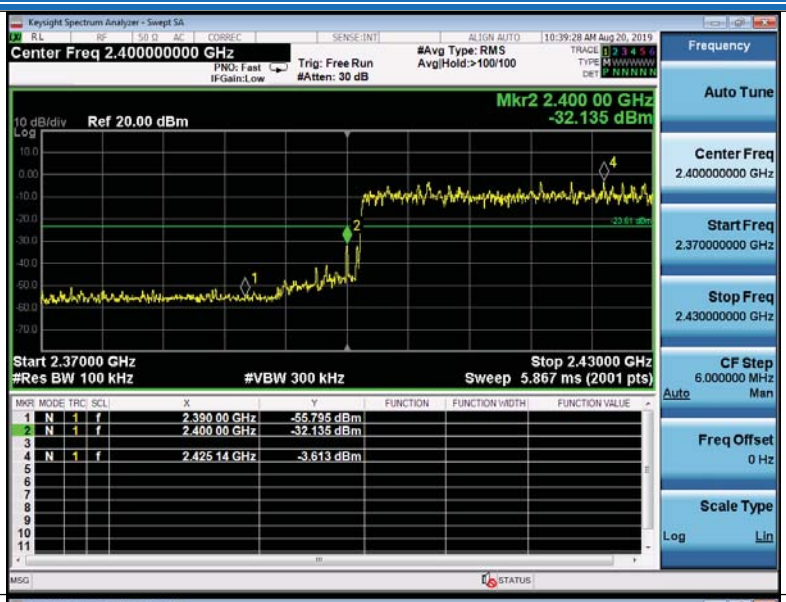
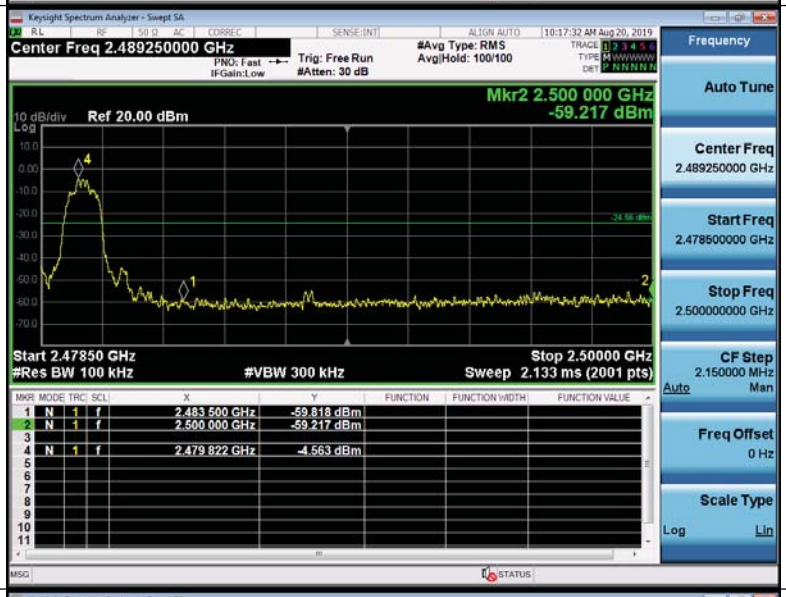
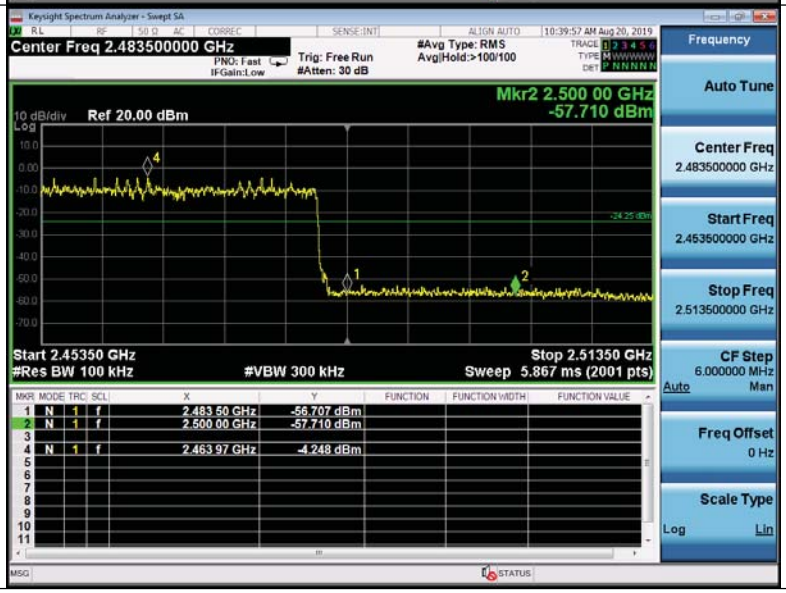
Test Requirement:	47 CFR Part 15C Section 15.247 (d)
Test Method:	ANSI C63.10:2013
Test Setup:	 *Remark: Offset=cable loss+ attenuation factor.*
Limit:	In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.
Exploratory Test Mode:	Hopping and Non-hopping transmitting with all kind of modulation and all kind of data type
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type. Only the worst case is recorded in the report.
Test Results:	Pass

Test plot as follows:

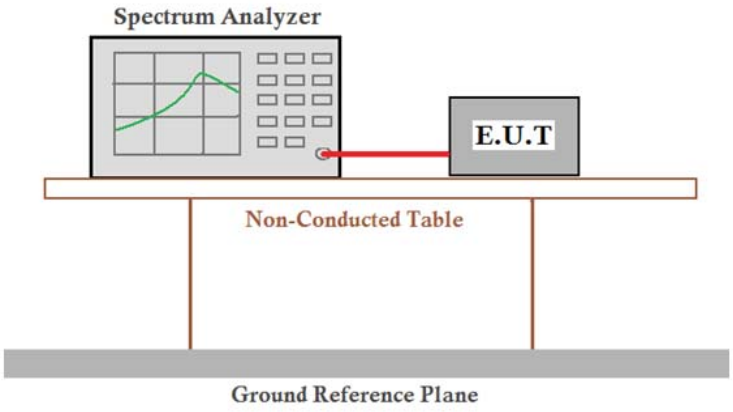
Graphs		
GFSK/LCH/No Hop		
GFSK/LCH/Hop		
GFSK/HCH/No Hop		

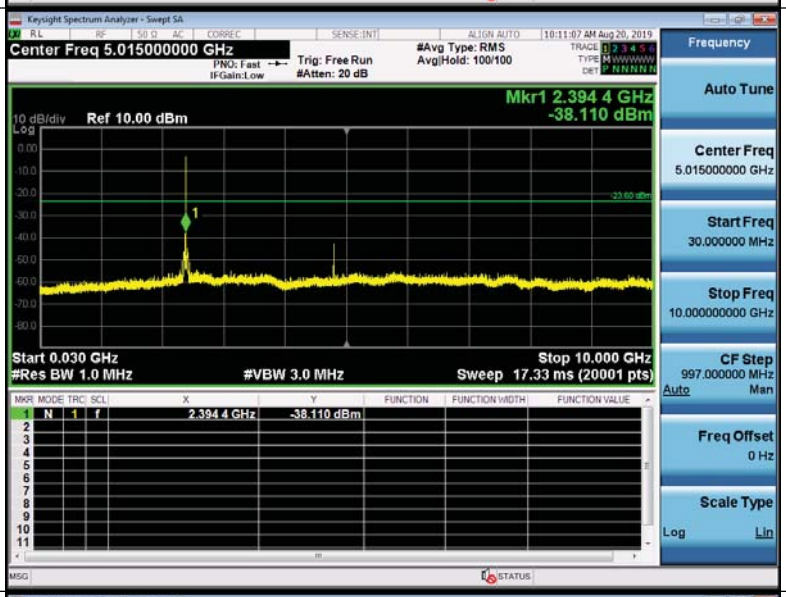
GFSK/HCH/Hop		
π/4DQPSK/LCH/No Hop		
π/4DQPSK/LCH/Hop		

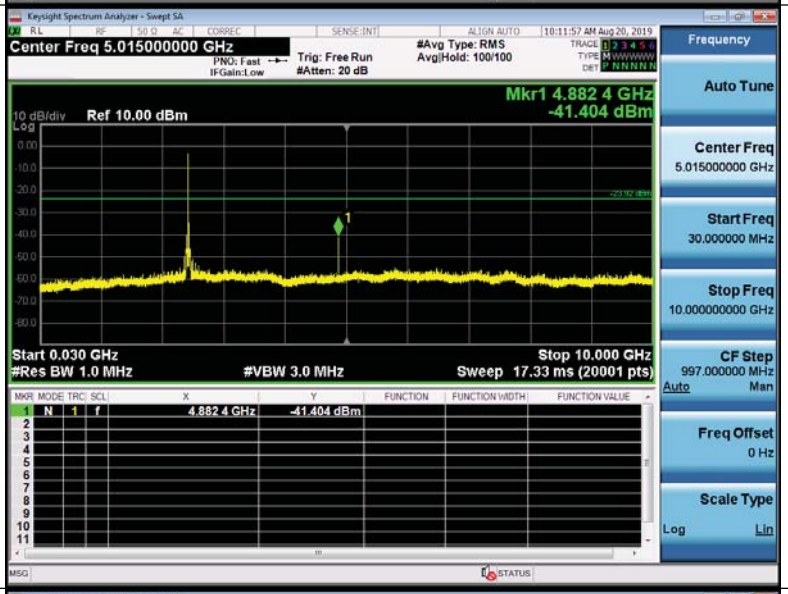
π/4DQPSK/HCH/No Hop		
π/4DQPSK/HCH/Hop		
8DPSK/ LCH/No Hop		

8DPSK / LCH/ Hop		
8DPSK / HCH/NO Hop		
8DPSK / HCH/Hop		

5.9. Spurious RF Conducted Emissions

Test Requirement:	47 CFR Part 15C Section 15.247 (d)
Test Method:	ANSI C63.10:2013
Test Setup:	 *Remark: Offset=cable loss+ attenuation factor.*
Limit:	In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type.
Test Results:	Pass

GFSK_LCH_Graphs			
Reference			
30MHz-10GHz			
10GHz-26.5GHz			

GFSK_MCH_Graphs		
Reference		
30MHz-10GHz		
10GHz-26.5GHz